User Manual
Instaltest XE

Distributor:

	Mark on your equipment certifies that this equipment meets the requirements of the EU (European Union) concerning safety and electromagnetic compatibility regulations

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1 Preface

Congratulations on your purchase of the InstalTest instrument and its accessories from NIEAF-SMITT. The instrument was designed on a basis of rich experience, acquired through many years of dealing with electric installation test equipment.

The InstalTest instrument is a professional, multifunctional, hand-held test instrument intended to perform all the measurements on a.c. electrical LV installations.

The following measurements and tests can be performed:

- ❑ Voltage and frequency,
- ❑ Continuity tests,
- ❑ Insulation resistance tests,
- ❑ RCD testing,
- ❑ Fault loop / RCD trip-lock impedance measurements,
- ❑ Line impedance / Voltage drop,
- ❑ Phase sequence,
- ❑ Earthing resistance tests,
- ❑ Pre-defined auto-sequences.

The graphic display with backlight offers easy reading of results, indications, measurement parameters and messages. Two LED PASS/FAIL indicators are placed at the sides of the LCD.
The operation of the instrument is designed to be as simple and clear as possible and no special training (except for the reading this instruction manual) is required in order to begin using the instrument.
In order for operator to be familiar enough with performing measurements in general and their typical applications it is advisable to read NIEAF-SMITT handbook ***Guide for testing and verification of low voltage installations***.

The instrument is equipped with the entire necessary accessory for comfortable testing.

2 Safety and operational considerations

2.1 Warnings and notes

In order to maintain the highest level of operator safety while carrying out various tests and measurements, NIEAF-SMITT recommends keeping your InstalTest instruments in good condition and undamaged. When using the instrument, consider the following general warnings:

⚠️**General warnings related to safety:**

❑ **The ⚠️ symbol on the instrument means »Read the Instruction manual with special care for safe operation«. The symbol requires an action!**

❑ **If the test equipment is used in a manner not specified in this user manual, the protection provided by the equipment could be impaired!**

❑ **Read this user manual carefully, otherwise the use of the instrument may be dangerous for the operator, the instrument or for the equipment under test!**

❑ **Do not use the instrument or any of the accessories if any damage is noticed!**

❑ **Consider all generally known precautions in order to avoid risk of electric shock while dealing with hazardous voltages!**

❑ **In case a fuse has blown follow the instructions in this manual in order to replace it! Use only fuses that are specified!**

❑ **Do not use the instrument in AC supply systems with voltages higher than 550 Va.c.**

❑ **Service, repairs or adjustment of instruments and accessories is only allowed to be carried out by a competent authorized personnel!**

❑ **Use only standard or optional test accessories supplied by your distributor!**

❑ **Consider that protection category of some accessories is lower than of the instrument. Test tips and Tip commander have removable caps. If they are removed the protection falls to CAT II. Check markings on accessories!**
         cap off, 18 mm tip: CAT II up to 1000 V
         cap on, 4 mm tip: CAT II 1000 V / CAT III600 V / CAT IV300 V

❑ **The instrument comes supplied with rechargeable Ni-MH battery cells. The cells should only be replaced with the same type as defined on the battery compartment label or as described in this manual. Do not use standard alkaline battery cells while the power supply adapter is connected, otherwise they may explode!**

❑ **Hazardous voltages exist inside the instrument. Disconnect all test leads, remove the power supply cable and switch off the instrument before removing battery compartment cover.**

❑ **All normal safety precautions must be taken in order to avoid risk of electric shock while working on electrical installations!**

⚠️ **Warnings related to safety of measurement functions:**

Insulation resistance

- ❑ Insulation resistance measurement should only be performed on de-energized objects!
- ❑ Do not touch the test object during the measurement or before it is fully discharged! Risk of electric shock!
- ❑ When an insulation resistance measurement has been performed on a capacitive object, automatic discharge may not be done immediately! The warning message 🔋 and the actual voltage are displayed during discharge until voltage drops below 30 V.
- ❑ Do not connect test terminals to external voltage higher than 600 V (AC or DC) in order not to damage the test instrument!

Continuity functions

- ❑ Continuity measurements should only be performed on de-energized objects!
- ❑ Parallel loops may influence on test results.

Testing PE terminal

- ❑ If phase voltage is detected on the tested PE terminal, stop all measurements immediately and ensure the cause of the fault is eliminated before proceeding with any activity!

Notes related to measurement functions:

General

- ❑ The 📟 indicator means that the selected measurement cannot be performed because of irregular conditions on input terminals.
- ❑ Insulation resistance, continuity functions and earth resistance measurements can only be performed on de-energized objects.
- ❑ PASS / FAIL indication is enabled when limit is set. Apply appropriate limit value for evaluation of measurement results.
- ❑ In the case that only two of the three wires are connected to the electrical installation under test, only voltage indication between these two wires is valid.

Insulation resistance

- ❑ The standard three-wire test lead, shuko test cable or Plug / Tip commanders can be used for the insulation test with voltages ≤ 1kV.
- ❑ If a voltage of higher than 30 V (AC or DC) is detected between test terminals, the insulation resistance measurement will not be performed.
- ❑ The instrument automatically discharge tested object after finished measurement.
- ❑ A double click of TEST key starts a continuous measurement.

Continuity functions

- ❑ If a voltage of higher than 10 V (AC or DC) is detected between test terminals, the continuity resistance test will not be performed.
- ❑ Compensate test lead resistance before performing a continuity measurement, where necessary.

Earth resistance

- ❑ If voltage between test terminals is higher than 30 V the resistance to earth measurement will not be performed.
- ❑ If a noise voltage higher than approx. 5 V is present between the H and E or S test terminals, " $\sim\!\!\!\sqrt{}$ " (noise) warning symbol will be displayed, indicating that the test result may not be correct!

RCD functions

- ❑ Parameters set in one function are also kept for other RCD functions!
- ❑ The measurement of contact voltage does not normally trip an RCD. However, the trip limit of the RCD may be exceeded as a result of leakage current flowing to the PE protective conductor or a capacitive connection between L and PE conductors.
- ❑ The RCD trip-lock sub-function (function selector switch in LOOP position) takes longer to complete but offers much better accuracy of fault loop resistance (in comparison to the R_L sub-result in Contact voltage function).
- ❑ RCD trip-out time and RCD trip-out current measurements will only be performed if the contact voltage in the pre-test at nominal differential current is lower than the set contact voltage limit!
- ❑ The auto-test sequence (RCD AUTO function) stops when trip-out time is out of allowable time period.

Z-LOOP

- ❑ The low limit prospective short-circuit current value depends on fuse type, fuse current rating, fuse trip-out time and impedance scaling factor.
- ❑ The specified accuracy of tested parameters is valid only if the mains voltage is stable during the measurement.
- ❑ Fault loop impedance measurements will trip an RCD.
- ❑ The measurement of fault loop impedance using trip-lock function does not normally trip an RCD. However, the trip limit may be exceeded if a leakage current flows to the PE protective conductor or if there is a capacitive connection between L and PE conductors.

Z-LINE / Voltage drop

- ❑ In case of measurement of $Z_{Line-Line}$ with the instrument test leads PE and N connected together the instrument will display a warning of dangerous PE voltage. The measurement will be performed anyway.
- ❑ Specified accuracy of tested parameters is valid only if mains voltage is stable during the measurement.
- ❑ L and N test terminals are reversed automatically according to detected terminal voltage (except in UK version).

Testing PE terminal

- ❑ PE terminal can be tested in RCD, LOOP and LINE function selector switch positions only!
- ❑ For correct testing of PE terminal, the TEST key has to be touched for a few seconds.
- ❑ Make sure to stand on non-isolated floor while carrying out the test, otherwise test result may be wrong!

PE conductor resistance

- ❑ The specified accuracy of tested parameters is valid only if the mains voltage is stable during the measurement.
- ❑ PE conductor resistance measurement will trip an RCD.

❑ The measurement of PE conductor resistance using trip-lock function does not normally trip an RCD. However, the trip limit may be exceeded if a leakage current flows to the PE protective conductor or if there is a capacitive connection between L and PE conductors.

AutoTest tests

See notes above for selected tests in Auto-sequence.

2.2 Battery and charging

The instrument uses six AA size alkaline or rechargeable Ni-MH battery cells. Nominal operating time is declared for cells with nominal capacity of 2100 mAh. Battery condition is always displayed in the lower right display part. In case the battery is too weak the instrument indicates this as shown in figure 2.1. This indication appears for a few seconds and then the instrument turns itself off.
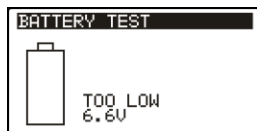
Figure 2.1: Discharged battery indication

The battery is charged whenever the power supply adapter is connected to the instrument. The power supply socket polarity is shown in figure 2.2. Internal circuit controls charging and assures maximum battery lifetime.

Figure 2.2: Power supply socket polarity

Symbols:

	Indication of battery charging
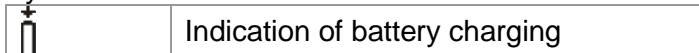
Figure 2.3: Charging indication

⚠️ **Warnings related to safety:**

- When connected to an installation, the instruments battery compartment can contain hazardous voltage inside! When replacing battery cells or before opening the battery/fuse compartment cover, disconnect any measuring accessory connected to the instrument and turn off the instrument,
- Ensure that the battery cells are inserted correctly otherwise the instrument will not operate and the batteries could be discharged.
- Do not recharge alkaline battery cells!
- Use only power supply adapter delivered from the manufacturer or distributor of the test equipment !

Notes:

- The charger in the instrument is a pack cell charger. This means that the battery cells are connected in series during the charging. The battery cells have to be equivalent (same charge condition, same type and age).
- If the instrument is not to be used for a long period of time, remove all batteries from the battery compartment.
- Alkaline or rechargeable Ni-MH batteries (size AA) can be used. NIEAF-SMITT recommends only using rechargeable batteries with a capacity of 2100mAh or above.
- Unpredictable chemical processes can occur during the charging of battery cells that have been left unused for a longer period (more than 6 months). In this case NIEAF-SMITT recommends repeating the charge/discharge cycle at least 2-4 times.
- If no improvement is achieved after several charge / discharge cycles, then each battery cell should be checked (by comparing battery voltages, testing them in a cell charger, etc).

It is very likely that only some of the battery cells are deteriorated. One different battery cell can cause an improper behaviour of the entire battery pack!

❑ The effects described above should not be confused with the normal decrease of battery capacity over time. Battery also loses some capacity when it is repeatedly charged / discharged. This information is provided in the technical specification from battery manufacturer.

2.3 Standards applied

The InstalTest instruments are manufactured and tested in accordance with the following regulations:

Electromagnetic compatibility (EMC)	
EN 61326	Electrical equipment for measurement, control and laboratory use – EMC requirements Class B (Hand-held equipment used in controlled EM environments)
Safety (LVD)	
EN 61010-1	Safety requirements for electrical equipment for measurement, control and laboratory use – Part 1: General requirements
EN 61010-2-030	Safety requirements for electrical equipment for measurement, control and laboratory use – Part 2-030: Particular requirements for testing and measuring circuits
EN 61010-031	Safety requirements for electrical equipment for measurement, control and laboratory use – Part 031: Safety requirements for hand-held probe assemblies for electrical measurement and test
EN 61010-2-032	Safety requirements for electrical equipment for measurement, control, and laboratory use - Part 2-032: Particular requirements for hand-held and hand-manipulated current sensors for electrical test and measurement
Functionality	
EN 61557	Electrical safety in low voltage distribution systems up to 1000 V_{AC} and 1500 V_{AC} – Equipment for testing, measuring or monitoring of protective measures Part 1: General requirements Part 2: Insulation resistance Part 3: Loop resistance Part 4: Resistance of earth connection and equipotential bonding Part 5: Resistance to earth Part 6: Residual current devices (RCDs) in TT and TN systems Part 7: Phase sequence Part 10: Combined measuring equipment Part 12: Performance measuring and monitoring devices (PMD)
Reference standards for electrical installations and components	
EN 61008	Residual current operated circuit-breakers without integral overcurrent protection for household and similar uses
EN 61009	Residual current operated circuit-breakers with integral overcurrent protection for household and similar uses
IEC 60364-4-41	Electrical installations of buildings Part 4-41 Protection for safety – protection against electric shock
BS 7671	IEE Wiring Regulations (17th edition)
AS/NZS 3017	Electrical installations – Verification guidelines

Note about EN and IEC standards:

❑ Text of this manual contains references to European standards. All standards of EN 6XXXX (e.g. EN 61010) series are equivalent to IEC standards with the same number (e.g. IEC 61010) and differ only in amended parts required by European harmonization procedure.

3 Instrument description

3.1 Front panel

Figure 3.1: Front panel

Legend:

1	**LCD**	128 x 64 dots matrix display with backlight.
2	**UP**	Modifies selected parameter.
3	**DOWN**	
4	**TEST**	TEST — Starts measurements. Acts also as the PE touching electrode.
5	**ESC**	Goes one level back.
6	**TAB**	Selects the parameters in selected function.
7	**Backlight, Contrast**	Changes backlight level and contrast.
8	**ON / OFF**	Switches the instrument power on or off. The instrument automatically turns off 15 minutes after the last key was pressed.
9	**HELP / CAL**	Accesses help menus. Calibrates test leads in Continuity functions. Starts Z_{REF} measurement in Voltage drop sub-function.
10	**Function selector switch**	Selects test / measurement function and settings.
11	**MEM**	Stores / recalls memory of instrument .
12	**Green LEDs Red LEDs**	Indicates PASS / FAIL of result.

3.2 Connector panel
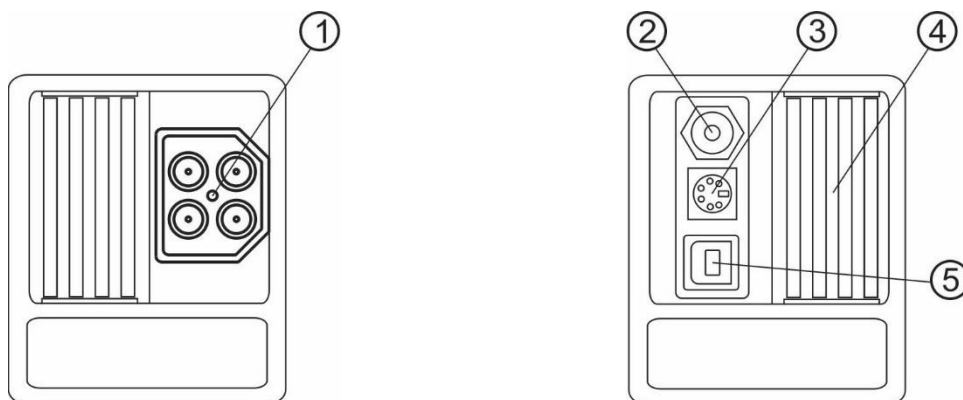
Figure 3.2: Connector panel

Legend:

1	**Test connector**	Measuring inputs / outputs.
2	**Charger socket**	
3	**PS/2 connector**	Communication with PC serial port Connection to barcode / RFID reader Connection of Bluetooth dongle
4	**Protection cover**	
5	**USB connector**	Communication with PC USB (1.1) port.

Warnings!

❑ Maximum allowed voltage between any test terminal and ground is 600 V!
❑ Maximum allowed voltage between test terminals on test connector is 600 V!
❑ Maximum short-term voltage of external power supply adapter is 14 V!

3.3 Back side
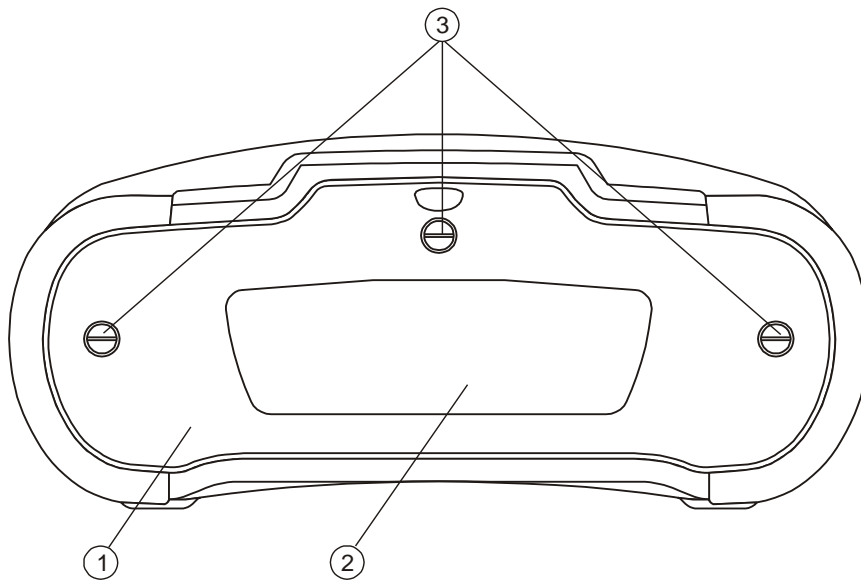
Figure 3.3: Back panel

Legend:

1	**Battery / fuse compartment cover**
2	**Back panel information label**
3	**Fixing screws for battery / fuse compartment cover**
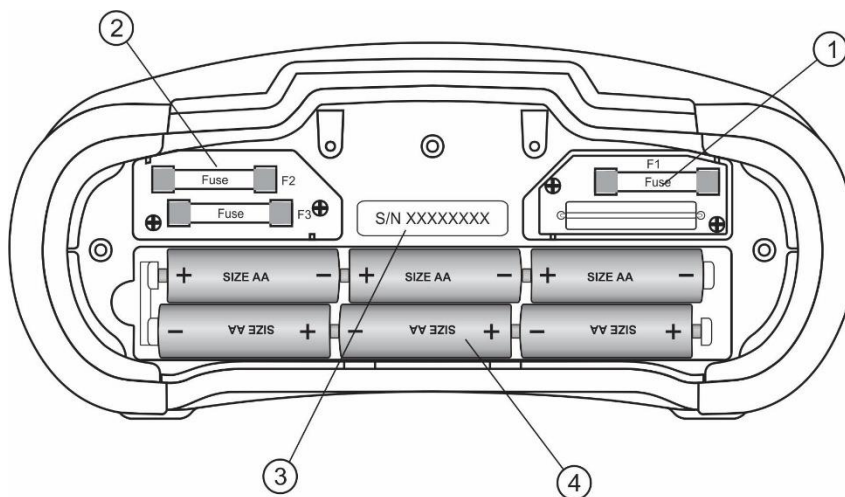
F
Figure 3.4: Battery and fuse compartment

Legend:

1	**Fuse F1**	M 315 mA / 250 V
2	**Fuses F2 and F3**	F 4 A / 500 V (breaking capacity 50 kA)
3	**Serial number label**	
4	**Battery cells**	Size AA, alkaline / rechargeable NiMH
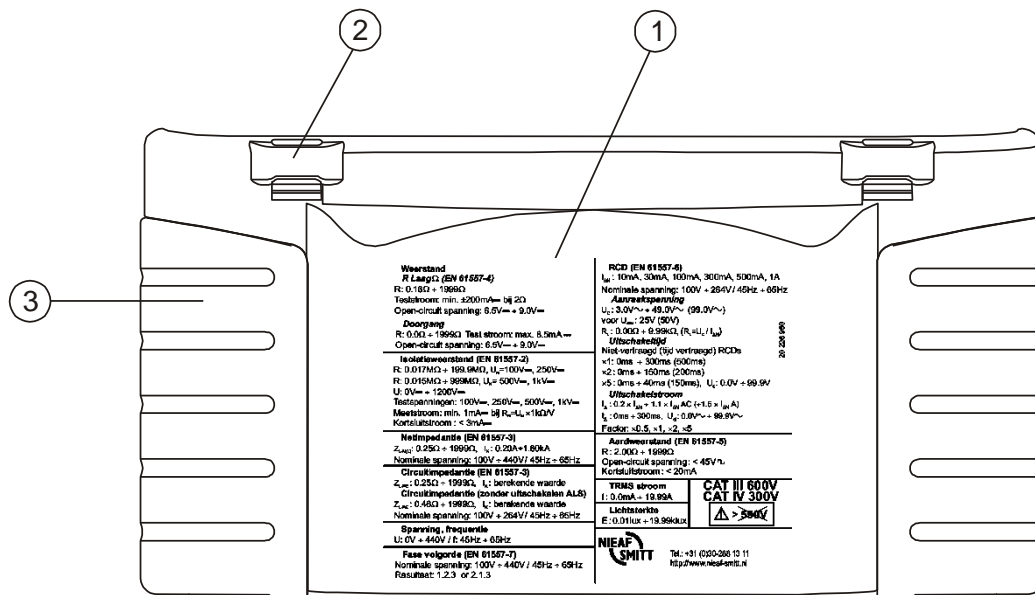
Figure 3.5: Bottom

Legend:

1	**Bottom information label**
2	**Neck belt openings**
3	**Handling side covers**

3.4 Carrying the instrument

With the neck-carrying belt supplied in standard set, various possibilities of carrying the instrument are available. Operator can choose appropriate one on basis of his operation, see the following examples:

The instrument hangs around operators neck only – quick placing and displacing.

The instrument can be used even when placed in soft carrying bag – test cable connected to the instrument through the front aperture.
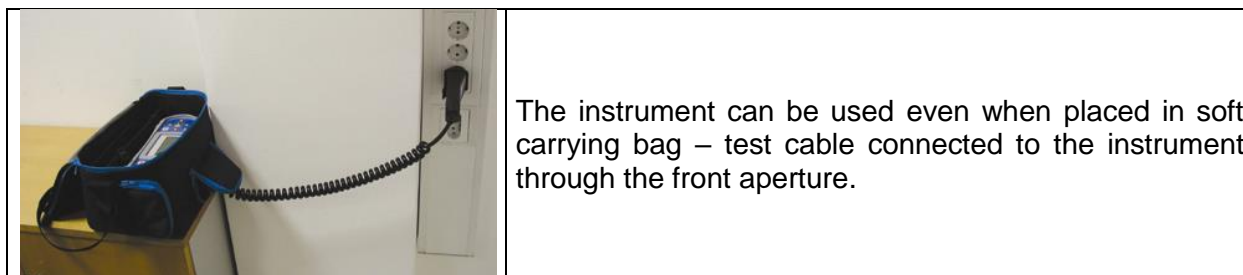
3.5 Instrument set and accessories

3.5.1 Standard set InstalTest XE

- ❑ Instrument
- ❑ Soft carrying bag
- ❑ Schuko-plug test cable
- ❑ Test lead, 3 x 1.5 m
- ❑ Test probe, 3 pcs
- ❑ Crocodile clip, 3 pcs
- ❑ Set of carrying straps
- ❑ RS232-PS/2 cable
- ❑ USB cable
- ❑ Set of Ni-MH battery cells
- ❑ Power supply adapter
- ❑ CD with instruction manual, "Guide for testing and verification of low voltage installations" handbook and PC software InstalLink   PRO.
- ❑ Short instruction manual
- ❑ Calibration Certificate

3.5.2 Optional accessories

See the attached sheet for a list of optional accessories that are available on request from your distributor.

4 Instrument operation

4.1 Display and sound

4.1.1 Terminal voltage monitor

The terminal voltage monitor displays on-line the voltages on the test terminals and information about active test terminals in the a.c. installation measuring mode.

	Online voltages are displayed together with test terminal indication. All three test terminals are used for selected measurement.
	Online voltages are displayed together with test terminal indication. L and N test terminals are used for selected measurement.
	L and PE are active test terminals; N terminal should also be connected for correct input voltage condition.
	Polarity of test voltage applied to the output terminals, L and N.

4.1.2 Battery indication

The battery indication indicates the charge condition of battery and connection of external charger.

	Battery capacity indication.
	Low battery. Battery is too weak to guarantee correct result. Replace or recharge the battery cells.
	Charging in progress (if power supply adapter is connected).

4.1.3 Messages

In the message field warnings and messages are displayed.

	Measurement is running, consider displayed warnings.
	Conditions on the input terminals allow starting the measurement; consider other displayed warnings and messages.
	Conditions on the input terminals do not allow starting the measurement, consider displayed warnings and messages.
	RCD tripped-out during the measurement (in RCD functions).
	Portable RCD selected (PRCD).
	Instrument is overheated. The measurement is prohibited until the temperature decreases under the allowed limit.
	Result(s) can be stored.

	High electrical noise was detected during measurement. Results may be impaired.
	L and N are changed.
	Warning! High voltage is applied to the test terminals.
	Warning! Dangerous voltage on the PE terminal! Stop the activity immediately and eliminate the fault / connection problem before proceeding with any activity!
	Test leads resistance in Continuity measurement is not compensated.
	Test leads resistance in Continuity measurement is compensated.
	High resistance to earth of test probes. Results may be impaired.
	Measured signal is out of range (clipped). Results are impaired.
	Fuse F1 is broken.

4.1.4 Results

✓	Measurement result is inside pre-set limits (PASS).
✗	Measurement result is out of pre-set limits (FAIL).
⊘	Measurement is aborted. Consider displayed warnings and messages.

4.1.5 Sound warnings

Continuous sound	**Warning!** Dangerous voltage on the PE terminal is detected.

4.1.6 Help screens

HELP	Opens help screen.

Help menus are available in all functions. The Help menu contains schematic diagrams for illustrating how to properly connect the instrument to electric installation. After selecting the measurement you want to perform, press the HELP key in order to view the associated Help menu.

Keys in help menu:

UP / DOWN	Selects next / previous help screen.
ESC / HELP / Function selector switch	Exits help menu.

Figure 4.1: Examples of help screens

4.1.7 Backlight and contrast adjustments

With the BACKLIGHT key backlight and contrast can be adjusted.

Click	Toggles backlight intensity level.
Keep pressed for **1 s**	Locks high intensity backlight level until power is turned off or the key is pressed again.
Keep pressed for **2 s**	Bar-graph for LCD contrast adjustment is displayed.
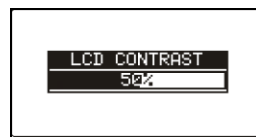
Figure 4.2: Contrast adjustment menu

Keys for contrast adjustment:

DOWN	Reduces contrast.
UP	Increases contrast.
TEST	Accepts new contrast.
ESC	Exits without changes.

4.2 Function selection

For selecting test / measurement function, entering settings menu and auto-test mode   the **FUNCTION SELECTOR SWITCH** shall be used.

Function selector switch and keys:

Function selector switch	Selects test / measurement function, enters settings menu and selects auto-test mode.
UP / DOWN	Selects sub-function in selected measurement function.
TAB	Selects the test parameter to be set or modified.
TEST	Runs selected test / measurement function.
MEM	Stores measured results / recalls stored results.
ESC	Exits back.

Keys in **test parameter** field:

UP / DOWN	Changes the selected parameter.
TAB	Selects the next measuring parameter.
Function selector switch	Toggles between the main functions.
MEM	Stores measured results / recalls stored results

General rule regarding enabling **parameters** for evaluation of measurement / test result:

	OFF	No limit values, indication: _ _ _.
Parameter	**ON**	**Value(s)** – results will be marked as PASS or FAIL in accordance with selected limit.

See chapter 5 ***Measurements*** for more information about the operation of the instrument test functions.

4.3 Settings

Different instrument options can be set in the SETTINGS menu.

Options are:
- ❑ recalling and clearing stored results ,
- ❑ selection of language,
- ❑ setting the date and time,
- ❑ selection of reference standard for RCD tests,
- ❑ entering Isc factor,
- ❑ commander support ,
- ❑ settings for Bluetooth communication ,
- ❑ setting the instrument to initial values.
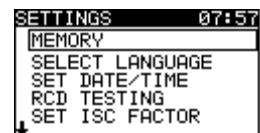
Figure 4.3: Options in Settings menu

Keys:

UP / DOWN	Selects appropriate option.
TEST	Enters selected option.
Function selector switch	Exits back to selected test / measurement function without changes.

4.3.1 Memory

In this menu the stored data can be recalled or deleted. See chapter 7 **Data handling** for more information.
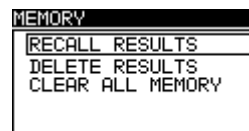
Figure 4.4: Memory options

Keys:

UP / DOWN	Selects option.
TEST	Enters selected option.
ESC	Exits back to settings menu.
Function selector switch	Exits back to selected test / measurement function without changes.

4.3.2 Language

In this menu the language can be set.

Figure 4.5: Language selection

Keys:

UP / DOWN	Selects language.
TEST	Confirms selected language and exits to settings menu.
ESC	Exits back to settings menu.
Function selector switch	Exits back to selected test / measurement function without changes.

4.3.3 Date and time

In this menu date and time can be set.
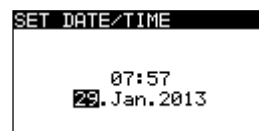
Figure 4.6: Setting date and time

Keys:

TAB	Selects the field to be changed.
UP / DOWN	Modifies selected field.
TEST	Confirms new date / time and exits.
ESC	Exits back to settings menu.
Function selector switch	Exits back to selected test / measurement function without changes.

Note:
❑ If the batteries are removed for more than 1 minute the set date and time will be lost.

4.3.4 RCD testing

In this menu the used standard for RCD tests can be set.
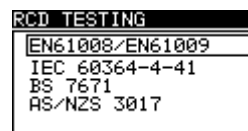
Figure 4.7: Selection of RCD test standard

Keys:

UP / DOWN	Selects standard.
TEST	Confirms selected standard.
ESC	Exits back to settings menu.
Function selector switch	Exits back to selected test / measurement without changes.

Maximum RCD disconnection times differ in various standards.
The trip-out times defined in individual standards are listed below.

Trip-out times according to EN 61008 / EN 61009:

	$\frac{1}{2} \times I_{\Delta N}$ *)	$I_{\Delta N}$	$2 \times I_{\Delta N}$	$5 \times I_{\Delta N}$
General RCDs (non-delayed)	$t_\Delta > 300$ ms	$t_\Delta < 300$ ms	$t_\Delta < 150$ ms	$t_\Delta < 40$ ms
Selective RCDs (time-delayed)	$t_\Delta > 500$ ms	130 ms $< t_\Delta < 500$ ms	60 ms $< t_\Delta < 200$ ms	50 ms $< t_\Delta < 150$ ms

Trip-out times according to EN 60364-4-41:

	½×$I_{\Delta N}$[*]	$I_{\Delta N}$	2×$I_{\Delta N}$	5×$I_{\Delta N}$
General RCDs (non-delayed)	t_Δ> 999 ms	t_Δ< 999 ms	t_Δ< 150 ms	t_Δ< 40 ms
Selective RCDs (time-delayed)	t_Δ> 999 ms	130 ms < t_Δ< 999 ms	60 ms < t_Δ< 200 ms	50 ms < t_Δ< 150 ms

Trip-out times according to BS 7671:

	½×$I_{\Delta N}$[*]	$I_{\Delta N}$	2×$I_{\Delta N}$	5×$I_{\Delta N}$
General RCDs (non-delayed)	t_Δ> 1999 ms	t_Δ< 300 ms	t_Δ< 150 ms	t_Δ< 40 ms
Selective RCDs (time-delayed)	t_Δ> 1999 ms	130 ms < t_Δ< 500 ms	60 ms < t_Δ< 200 ms	50 ms < t_Δ< 150 ms

Trip-out times according to AS/NZS 3017[**]:

RCD type	$I_{\Delta N}$ [mA]	½×$I_{\Delta N}$[*] t_Δ	$I_{\Delta N}$ t_Δ	2×$I_{\Delta N}$ t_Δ	5×$I_{\Delta N}$ t_Δ	Note
I	≤ 10		40 ms	40 ms	40 ms	
II	> 10 ≤ 30	> 999 ms	300 ms	150 ms	40 ms	Maximum break time
III	> 30		300 ms	150 ms	40 ms	
IV Ⓢ	> 30	> 999 ms	500 ms	200 ms	150 ms	
			130 ms	60 ms	50 ms	Minimum non-actuating time

[*] Minimum test period for current of ½×$I_{\Delta N}$, RCD shall not trip-out.
[**] Test current and measurement accuracy correspond to AS/NZS 3017 requirements.

Maximum test times related to selected test current for general (non-delayed) RCD

Standard	½×$I_{\Delta N}$	$I_{\Delta N}$	2×$I_{\Delta N}$	5×$I_{\Delta N}$
EN 61008 / EN 61009	300 ms	300 ms	150 ms	40 ms
EN 60364-4-41	1000 ms	1000 ms	150 ms	40 ms
BS 7671	2000 ms	300 ms	150 ms	40 ms
AS/NZS 3017 (I, II, III)	1000 ms	1000 ms	150 ms	40 ms

Maximum test times related to selected test current for selective (time-delayed) RCD

Standard	½×$I_{\Delta N}$	$I_{\Delta N}$	2×$I_{\Delta N}$	5×$I_{\Delta N}$
EN 61008 / EN 61009	500 ms	500 ms	200 ms	150 ms
EN 60364-4-41	1000 ms	1000 ms	200 ms	150 ms
BS 7671	2000 ms	500 ms	200 ms	150 ms
AS/NZS 3017 (IV)	1000 ms	1000 ms	200 ms	150 ms

Note:
- Trip-out limit times for PRCD, PRCD-K and PRCD-S are equal to General (non-delayed) RCDs.

4.3.5 Isc factor

In this menu the Isc factor for calculation of short circuit current in Z-LINE and Z-LOOP measurements can be set.

SET Isc FACTOR
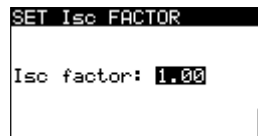
Isc factor: 1.00

Figure 4.8: Selection of Isc factor

Keys:

UP / DOWN	Sets Isc value.
TEST	Confirms Isc value.
ESC	Exits back to settings menu.
Function selector switch	Exits back to selected test / measurement function without changes.

Short circuit current Isc in the supply system is important for selection or verification of protective circuit breakers (fuses, over-current breaking devices, RCDs).
The default value of Isc factor (ksc) is 1.00. The value should be set according to local regulative. Range for adjustment of the Isc factor is $0.20 \div 3.00$.

4.3.6 Commander support

The support for remote commanders can be enabled or disabled in this menu.

COMMANDER
A1314,A1401
COMMANDER DISABLED
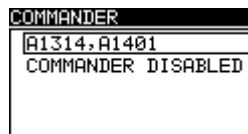
Figure 4.9: Selection of commander support

Keys:

UP / DOWN	Selects commander option.
TEST	Confirms selected option.
ESC	Exits back to settings menu.
Function selector switch	Exits back to selected test / measurement function without changes.

Note:
- Commander disabled option is intended to disable the commander's remote keys. In the case of high EM interfering noise the operation of the commander can be irregular.

4.3.7 Communication

In this menu the Bluetooth dongle A1436 can be initialized and device for scanning barcodes can be selected.

COMMUNICATION
INIT. BT DONGLE
SCANNER TYPE

Figure 4.10: Communication menu

Keys:

UP / DOWN	Selects option.
TEST	Confirms selected option.
ESC	Exits back to settings menu.
Function selector switch	Exits back to selected test / measurement function without changes.

Initialization of the Bluetooth dongle

The Bluetooth dongle A1436 should be initialized when it is used with the instrument for the first time. During initialization the instrument sets the dongle parameters and name in order to communicate properly with PC and other devices via Bluetooth.

Initialization procedure

> ❑ Connect Bluetooth dongle A1436 to the instrument.
> ❑ Press **RESET key** on the Bluetooth dongle A1436 for **at least 10 seconds.**
> ❑ Select *INIT. BT DONGLE* in *Communication menu* and press the **TEST key**.
> ❑ Wait for confirmation message and beep. Following message is displayed if dongle was initialized properly: **EXTERNAL BT DONGLE SEARCHING OK!**

Notes:
> ❑ The Bluetooth dongle A1436 should always be initialized before first use with the instrument.
> ❑ If the dongle was initialized by another Nieaf-Smitt instrument it will probably not work properly when working with the instrument again.
> ❑ For more information about communication via Bluetooth refer to chapter *7.6 Communication* and A1436 manual.

Selection of barcode scanner type

In this menu the barcode scanner type can be set. Options are:
> ❑ serial barcode scanner and
> ❑ barcode scanner application on Android devices.

Keys:

UP / DOWN	Selects option.
TEST	Confirms selected option.
ESC	Exits back to Communication menu.
Function selector switch	Exits back to selected test / measurement function without changes.
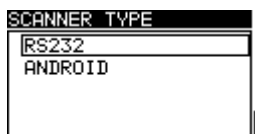
Figure 4.11: Menu for scanner type

4.3.8 Initial settings

In this menu the instrument settings, measurement parameters and limits can be set to initial (factory) values.
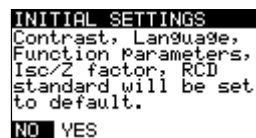
Figure 4.12: Initial settings dialogue

Keys:

UP / DOWN	Selects option [YES, NO].
TEST	Restores default settings (if YES is selected).
ESC	Exits back to settings menu.
Function selector switch	Exits back to selected test / measurement function without changes.

Warnings:
- ❑ Customized settings will be lost when this option is used!
- ❑ If the batteries are removed for more than 1 minute the custom made settings will be lost.

The default setup is listed below:

Instrument setting	Default value
Language	English
Contrast	As defined and stored by adjustment procedure
Isc factor	1.00
RCD standards	EN 61008 / EN 61009
Commander	A 1314, A 1401
Scanner type	RS 232

Test mode:
    Function
        Sub-function
	Parameters / limit value

INSTALLATION:	
EARTH RE	No limit
R ISO	No limit Utest = 500 V

Low Ohm Resistance
      R LOWΩ
      CONTINUITY
	
	No limit
	No limit, sound OFF

Rpe
      Rpe
      Rpe(rcd)
	
	No limit
	No limit

Z - LINE VOLTAGE DROP	Fuse type: none selected ΔU: 4.0 % Z_{REF}: 0.00 Ω
Z - LOOP	Fuse type: none selected
Zs rcd	Fuse type: none selected
RCD	RCD t

	Nominal differential current: $I_{\Delta N}$=30 mA
	RCD type: AC, non-delayed
	Test current starting polarity: ⏦ (0°)
	Limit contact voltage: 50 V
	Current multiplier: ×1
AUTO SEQUENCES :	
AUTO TT	FUSE: None selected
	Z_{REF}: ---
	ΔU: 4.0 %
	RCD: 30 mA, AC, non-delayed, ⏦ (0°)
	Uc: 50 V
AUTO TN (rcd)	FUSE: None selected
	Z_{REF}: ---
	ΔU: 4.0 %
	Rpe: No limit
AUTO TN	FUSE: None selected
	Z_{REF}: ---
	ΔU: 4.0 %
	Rpe: No limit

Note:
- Initial settings (reset of the instrument) can be recalled also if the TAB key is pressed while the instrument is switched on.

5 Measurements

5.1 Voltage, frequency and phase sequence

Voltage and frequency measurement is always active in the terminal voltage monitor. In the special **VOLTAGE TRMS menu** the measured voltage, frequency and information about detected three-phase connection can be stored. Measurements are based on the EN 61557-7 standard.

See chapter **4.2 Function selection** for instructions on key functionality.
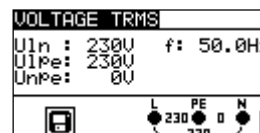
Figure 5.1: Voltage in single phase system

Test parameters for voltage measurement

There are no parameters to be set.

Connections for voltage measurement
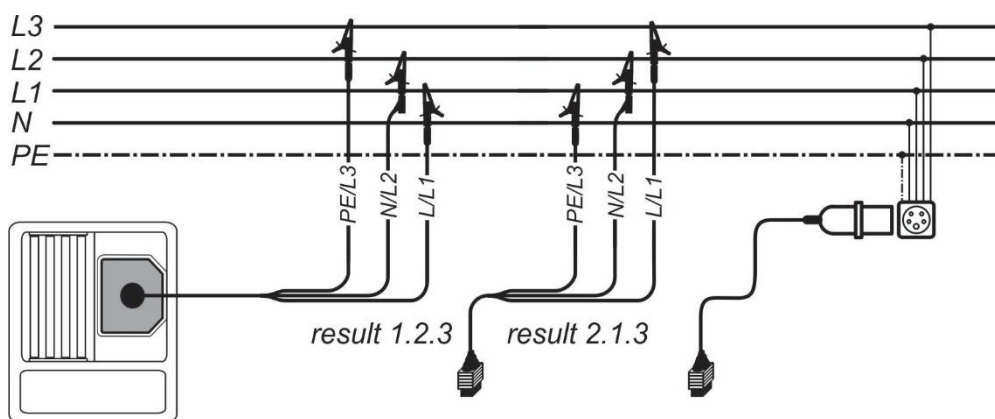
Figure 5.2: Connection of 3-wire test lead and optional adapter in three-phase system
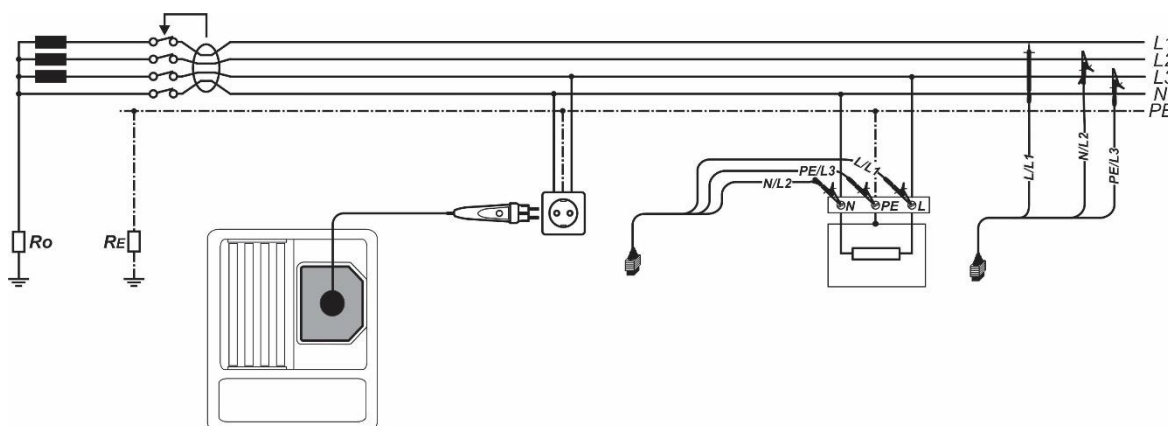
Figure 5.3: Connection of plug commander and 3-wire test lead in single-phase system

Voltage measurement procedure

❑   Select the `VOLTAGE TRMS` function using the function selector switch.
❑   **Connect** test cable to the instrument.
❑   **Connect** test leads to the item to be tested (see *Figure 5.2* and *Figure 5.3*).
❑   **Store** voltage measurement result by pressing the **MEM** key   .

Measurement runs immediately after selection of `VOLTAGE TRMS` function.

Figure 5.4: Examples of voltage measurement in three-phase system

Displayed results for single phase system:

Uln .... voltage between phase and neutral conductors
Ulpe .... voltage between phase and protective conductors
Unpe .... voltage between neutral and protective conductors
f .... frequency

Displayed results for three-phase system:

U12 .... voltage between phases L1 and L2
U13 .... voltage between phases L1 and L3
U23 .... voltage between phases L2 and L3
1.2.3 .... correct connection – CW rotation sequence
3.2.1 .... invalid connection – CCW rotation sequence
f .... frequency

5.2 Insulation resistance

The insulation resistance measurement is performed in order to ensure safety against electric shock through insulation. Typical applications are:
- ❑ insulation resistance between conductors of installation,
- ❑ insulation resistance of non-conductive rooms (walls and floors),
- ❑ insulation resistance of ground cables and
- ❑ resistance of semi-conductive (antistatic) floors.

See chapter ***4.2 Function selection*** for instructions on key functionality.
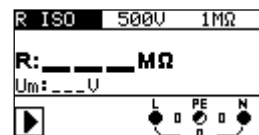
Figure 5.5: Insulation resistance

Test parameters for insulation resistance measurement

Uiso	**Nominal test voltage** [50 V, 100 V, 250 V, 500 V, 1000 V]
Limit	**Minimum insulation resistance** [OFF, 0.01 MΩ ÷ 200 MΩ]

Test circuits for insulation resistance
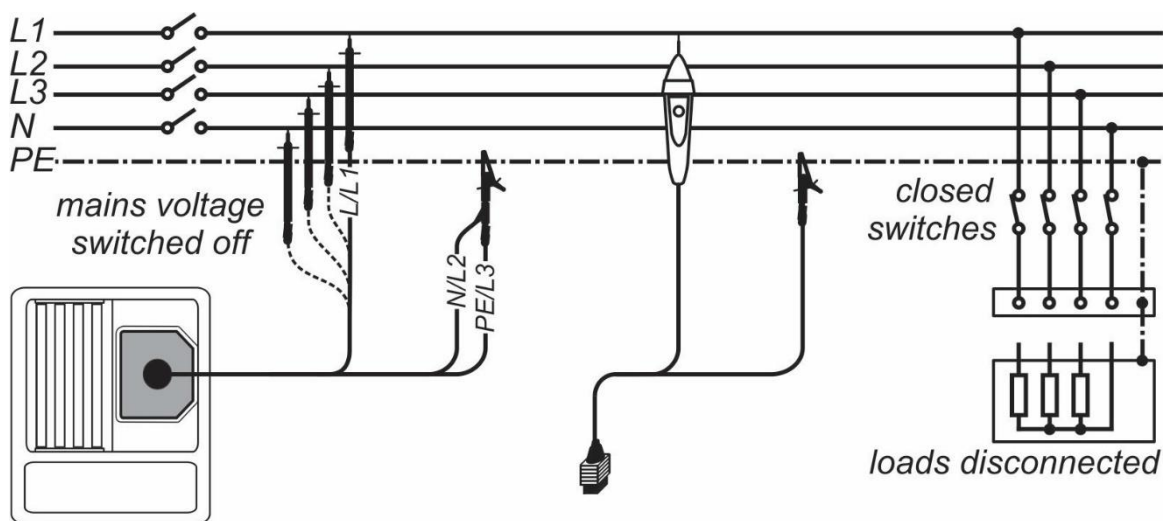
Figure 5.6: Connection of 3-wire test lead and tip commander

Insulation resistance measuring procedure

- ❑ Select the R ISO function using the function selector switch.
- ❑ Set the required **test voltage**.
- ❑ Enable and set **limit** value (optional).
- ❑ **Disconnect** tested installation from mains supply (and discharge insulation as required).
- ❑ **Connect** test cable to the instrument and to the item to be tested (see *Figure 5.6*).
- ❑ Press the **TEST** key to perform the measurement (double click for continuous measurement and later press to stop the measurement).
- ❑ After the measurement is finished wait until tested item is fully discharged.
- ❑ **Store** the result by pressing the **MEM** key .
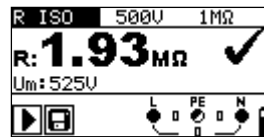
Figure 5.7: Example of insulation resistance measurement result

Displayed results:
      R .... insulation resistance
      Um .... test voltage (actual value)

5.3 Resistance of earth connection and equipotential bonding

The resistance measurement is performed in order to ensure that the protective measures against electric shock through earth connections and bondings are effective. Two sub-functions are available:

❑ R LOWΩ - Earth bond measurement according to EN 61557-4 (200 mA) and
❑ CONTINUITY - Continuous resistance measurement performed with 7 mA.

See chapter ***4.2 Function selection*** for instructions on key functionality.
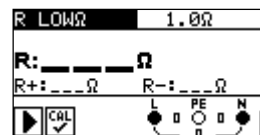
Figure 5.8: 200 mA RLOW Ω

Test parameters for resistance measurement

Test	Resistance measurement sub-function [R LOWΩ, CONTINUITY]
Limit	**Maximum resistance** [OFF, 0.1 Ω ÷ 20.0 Ω]

Additional test parameter for **Continuity sub-function**

📢·ıı	**Buzzer** On (sound if resistance is lower than the set limit value) or Off

Additional key:

HELP	*Click*	Calibrates test leads in Continuity functions.
	Keep pressed for 1s	Enters Help screen

5.3.1 R LOWΩ, 200 mA resistance measurement

The resistance measurement is performed with automatic polarity reversal of the test voltage.

Test circuit for R LOWΩ measurement
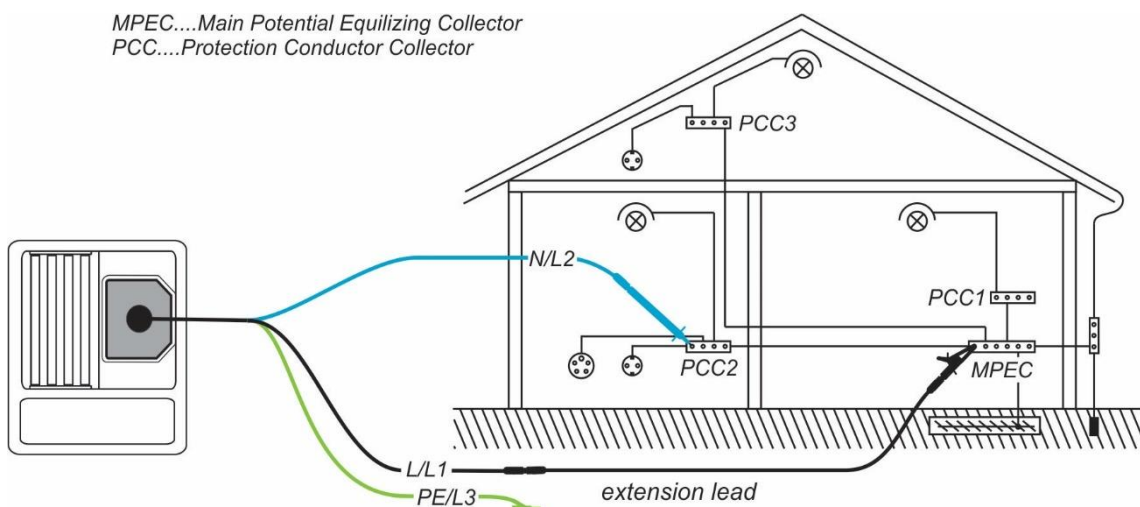
Figure 5.9: Connection of 3-wire test lead plus optional extension lead

R LOWΩ measurement procedure

- ❑ Select R LOWΩ function using the function selector switch.
- ❑ Set sub-function to R LOWΩ using **UP / DOWN** keys.
- ❑ Enable and set **limit** (optional).
- ❑ **Connect** test cable to the instrument.
- ❑ **Compensate** the test leads resistance (if necessary, see section *5.3.3 Compensation of test leads resistance).*
- ❑ **Disconnect** from mains supply and discharge installation to be tested.
- ❑ **Connect** the test leads to the appropriate PE wiring (see *Figure 5.9).*
- ❑ Press the **TEST** key to perform the measurement.
- ❑ After the measurement is finished **store** the result by pressing the **MEM** button .
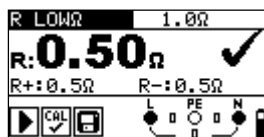
Figure 5.10: Example of RLOW result

Displayed result:

  R .... R LOWΩ resistance
  R+ .... result at positive polarity
  R- .... result at negative test polarity

5.3.2 Continuous resistance measurement with low current

In general, this function serves as standard Ω-meter with a low testing current. The measurement is performed continuously without polarity reversal. The function can also be applied for testing continuity of inductive components.

Test circuit for continuous resistance measurement
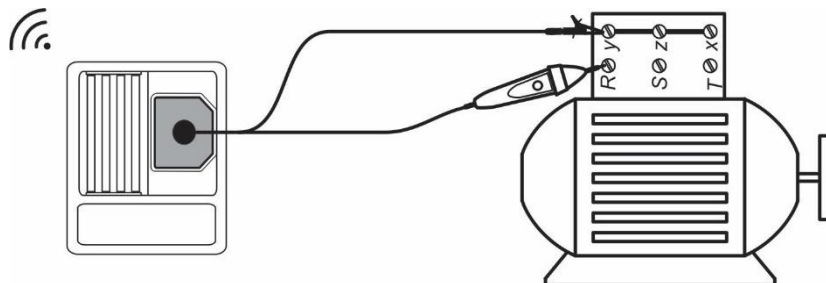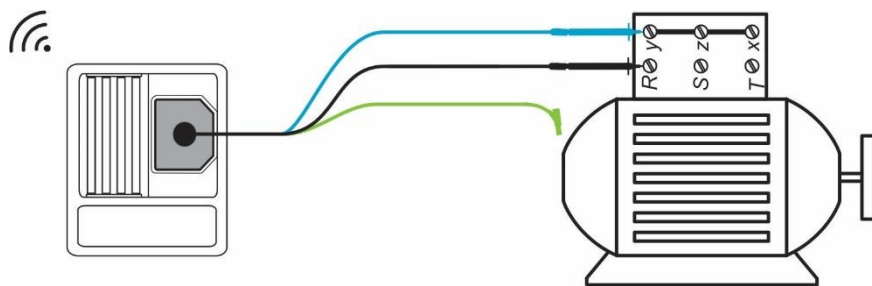
Figure 5.11: Tip commander and 3-wire test lead applications

Continuous resistance measurement procedure

- ❏ Select R Low function using the function selector switch.
- ❏ Set sub-function to CONTINUITY using **UP / DOWN** keys.
- ❏ Enable and set the **limit** (optional).
- ❏ **Connect** test cable to the instrument.
- ❏ **Compensate** test leads resistance (if necessary, see section *5.3.3 Compensation of test leads resistance).*
- ❏ **Disconnect** from mains supply and discharge the object to be tested.
- ❏ **Connect** test leads to the tested object (see *Figure 5.11*).
- ❏ Press the **TEST** key to begin performing a continuous measurement.
- ❏ Press the **TEST** key to stop measurement.
- ❏ After the measurement is finished **store** the result by pressing the **MEM** button
  .
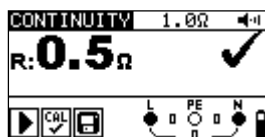
Figure 5.12: Example of continuous resistance measurement

Displayed result:

R .... resistance

5.3.3 Compensation of test leads resistance

This chapter describes how to compensate the test leads resistance in both continuity functions, R LOWΩ and CONTINUITY. Compensation is required to eliminate the influence of test leads resistance and the internal resistances of the instrument on the measured resistance. The lead compensation is therefore a very important feature to obtain correct result.

CAL symbol is displayed if the compensation was carried out successfully.

Circuits for compensating the resistance of test leads
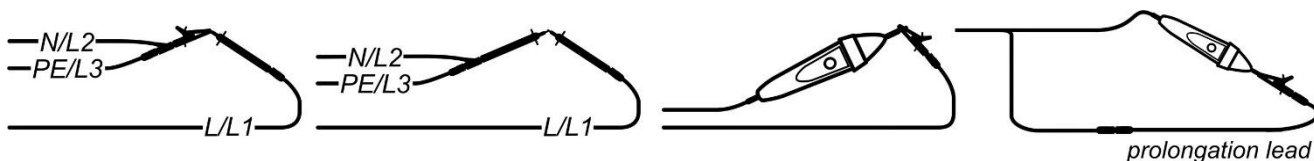
Figure 5.13: Shorted test leads

Compensation of test leads resistance procedure

❑ Select R LOWΩ or CONTINUITY function.
❑ **Connect** test cable to the instrument and short the test leads together (*see Figure 5.13*).
❑ Press the **TEST** key to perform resistance measurement.
❑ Press the **CAL** key to compensate leads resistance.
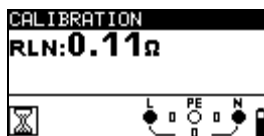
Figure 5.14: Results with old calibration values

Figure 5.15: Results with new calibration values

Note:
❑ The highest value for lead compensation is 5 Ω. If the resistance is higher the compensation value is set back to default value.

is displayed if no calibration value is stored.

5.4 Testing RCDs

Various test and measurements are required for verification of RCD(s) in RCD protected installations. Measurements are based on the EN 61557-6 standard.
The following measurements and tests (sub-functions) can be performed:

- ❑ contact voltage,
- ❑ trip-out time,
- ❑ trip-out current and
- ❑ RCD auto-test.

See chapter *4.2 Function selection* for instructions on key functionality.
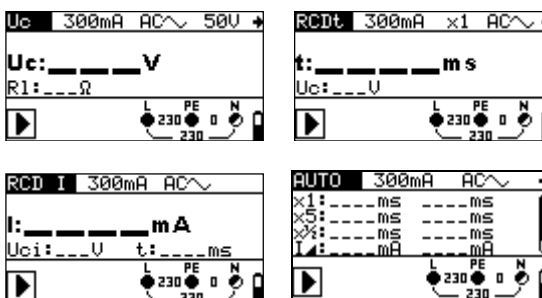
Figure 5.16: RCD tests

Test parameters for RCD test and measurement

TEST	**RCD sub-function test** [Uc, RCDt, RCD I, AUTO]
I□N	**Rated RCD residual current sensitivity I□N** [10 mA, 30 mA, 100 mA, 300 mA, 500 mA, 1000 mA].
type	**RCD type** [AC, A, F]. **starting polarity** [∿, ⌄, ⌃–, ⌄⁻]. **Characteristic and PRCD selection** [selective Ⓢ, general non-delayed ▢, PRCD, PRCD-K, PRCD-S].
MUL	**Multiplication factor for test current** [½, 1, 2, 5 I□N].
Ulim	**Conventional touch voltage limit** [25 V, 50 V].

Notes:

- ❑ Ulim can be selected in the Uc sub-function only.
- ❑ Selective (time-delayed) RCDs have delayed response characteristics. As the contact voltage pre-test or other RCD tests influence the time delayed RCD it takes a certain period to recover into normal state. Therefore a time delay of 30 s is inserted before performing trip-out test by default.
- ❑ Portable RCDs (PRCD, PRCD-K and PRCD-S) are tested as general (non-delayed) RCDs. Trip-out times, trip-out currents and contact voltage limits are equal to limits of general (non-delayed) RCDs.

Connections for testing RCD
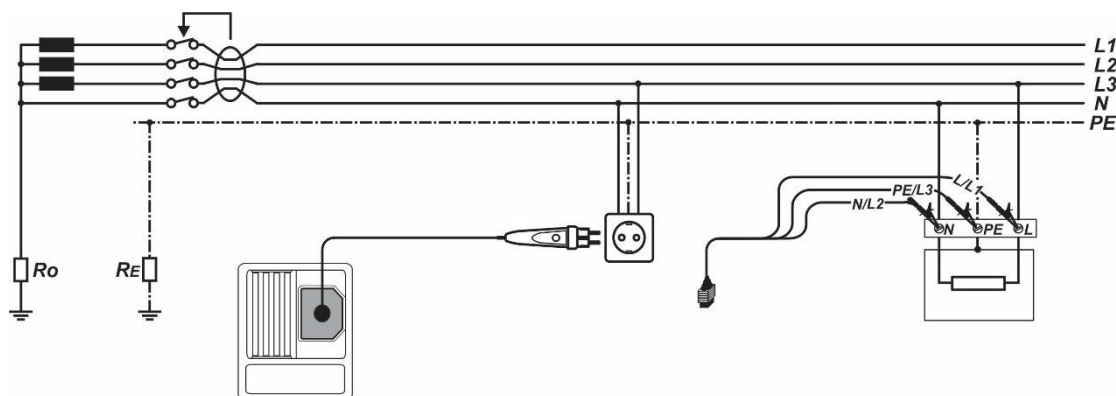
Figure 5.17: Connecting the plug commander and the 3-wire test lead

5.4.1 Contact voltage (RCD Uc)

A current flowing into the PE terminal causes a voltage drop on earth resistance, i.e. voltage difference between PE equipotential bonding circuit and earth. This voltage difference is called contact voltage and is present on all accessible conductive parts connected to the PE. It shall always be lower than the conventional safety limit voltage.

The contact voltage is measured with a test current lower than ½ $I_{\Box N}$ to avoid trip-out of the RCD and then normalized to the rated $I_{\Delta N}$.

Contact voltage measurement procedure

> ❑ Select the **RCD** function using the function selector switch.
> ❑ Set sub-function to **Uc** using **UP / DOWN** keys.
> ❑ Set test **parameters** (if necessary).
> ❑ **Connect** test cable to the instrument.
> ❑ **Connect** test leads to the item to be tested (see *Figure 5.17*).
> ❑ Press the **TEST** key to perform the measurement.
> ❑ **Store** the result by pressing the **MEM** key   .

The contact voltage result relates to the rated nominal residual current of the RCD and is multiplied by an appropriate factor (depending on RCD type and type of test current). The 1.05 factor is applied to avoid negative tolerance of result. See *Table 5.1* for detailed contact voltage calculation factors.

RCD type		Contact voltage Uc proportional to	Rated $I_{\Box N}$
AC		$1.05 \times I_{\Delta N}$	any
AC	Ⓢ	$2 \times 1.05 \times I_{\Delta N}$	
A, F		$1.4 \times 1.05 \times I_{\Delta N}$	≥ 30 mA
A, F	Ⓢ	$2 \times 1.4 \times 1.05 \times I_{\Delta N}$	
A, F		$2 \times 1.05 \times I_{\Delta N}$	< 30 mA
A, F	Ⓢ	$2 \times 2 \times 1.05 \times I_{\Delta N}$	

Table 5.1: Relationship between Uc and $I_{\Delta N}$

Loop resistance is indicative and calculated from Uc result (without additional proportional factors) according to: $R_L = \dfrac{U_C}{I_{\Delta N}}$.
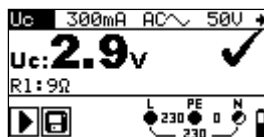
Figure 5.18: Example of contact voltage measurement results

Displayed results:

> **Uc** ....contact voltage
> **RI** ....fault loop resistance

5.4.2 Trip-out time (RCDt)

Trip-out time measurement verifies the sensitivity of the RCD at different residual currents.

Trip-out time measurement procedure

> ❑ Select the **RCD** function using the function selector switch.
> ❑ Set sub-function to **RCDt** using **UP / DOWN** keys.
> ❑ Set test **parameters** (if necessary).
> ❑ **Connect** test cable to the instrument.
> ❑ **Connect** test leads to the item to be tested (see *Figure 5.17*).
> ❑ Press the **TEST** key to perform the measurement.
> ❑ **Store** the result by pressing the **MEM** key   .
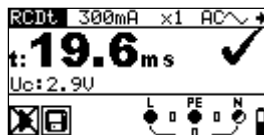
Figure 5.19: Example of trip-out time measurement results

Displayed results:

> **t**............trip-out time
> **Uc** ....contact voltage for rated I$_{\Delta N}$

5.4.3 Trip-out current (RCD I)

A continuously rising residual current is intended for testing the threshold sensitivity for RCD trip-out. The instrument increases the test current in small steps through appropriate range as follows:

RCD type	Slope range		Waveform	Notes
	Start value	**End value**		
AC	$0.2 \times I_{\Delta N}$	$1.1 \times I_{\Delta N}$	Sine	All models
A, F (I$_{\Delta N} \geq$ 30 mA)	$0.2 \times I_{\Delta N}$	$1.5 \times I_{\Delta N}$	Pulsed	
A, F (I$_{\Delta N}$ = 10 mA)	$0.2 \times I_{\Delta N}$	$2.2 \times I_{\Delta N}$		

Maximum test current is I_Δ (trip-out current) or end value in case the RCD didn't trip-out.

Trip-out current measurement procedure

> ❑ Select the RCD function using the function selector switch.
> ❑ Set sub-function to RCD I using **UP / DOWN** keys.
> ❑ Set test **parameters** (if necessary).
> ❑ **Connect** test cable to the instrument.
> ❑ **Connect** test leads to the item to be tested (see *Figure 5.17*).
> ❑ Press the **TEST** key to perform the measurement.
> ❑ **Store** the result by pressing the **MEM** key   .

Figure 5.20: Trip-out current measurement result example

Displayed results:
> **I**............trip-out current
> **Uci** ....contact voltage at trip-out current I or end value in case the RCD didn't trip
> **t**............trip-out time

5.4.4 RCD Auto-test

RCD auto-test function is intended to perform a complete RCD test (trip-out time at different residual currents, trip-out current and contact voltage) in one set of automatic tests, guided by the instrument.

Additional key:

HELP	*Click*	Toggles between top and bottom part of results field.
	Keep pressed for 1s	Enters Help screen

RCD Auto-test procedure

RCD Auto-test steps	**Notes**
❑ Select the **RCD** function using the function selector switch. ❑ Set sub-function to **AUTO** using **UP / DOWN** keys. ❑ Set test **parameters** (if necessary). ❑ **Connect** test cable to the instrument. ❑ **Connect** test leads to the item to be tested (see *Figure 5.17*). ❑ Press the **TEST** key to perform the test.	Start of test
❑ Test with $I_{\Delta N}$, 0° (step 1).	RCD should trip-out
❑ **Re-activate RCD**. ❑ Test with $I_{\Delta N}$, 180° (step 2).	RCD should trip-out
❑ **Re-activate RCD**. ❑ Test with $5{\times}I_{\Delta N}$, 0° (step 3).	RCD should trip-out
❑ **Re-activate RCD**. ❑ Test with $5{\times}I_{\Delta N}$, 180° (step 4).	RCD should trip-out
❑ **Re-activate RCD**. ❑ Test with $\frac{1}{2}{\times}I_{\Delta N}$, 0° (step 5).	RCD should not trip-out
❑ Test with $\frac{1}{2}{\times}I_{\Delta N}$, 180° (step 6).	RCD should not trip-out
❑ Trip-out current test, 0° (step 7).	RCD should trip-out
❑ **Re-activate RCD**. ❑ Trip-out current test, 180° (step 8).	RCD should trip-out
❑ **Re-activate RCD**. ❑ **Store** the result by pressing the **MEM** key .	End of test

Result examples:

Step 1

Step 2

Step 3   *Step 4*

Step 5   *Step 6*

Step 7   *Step 8*
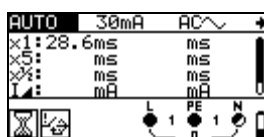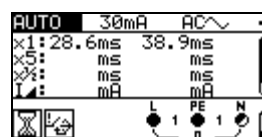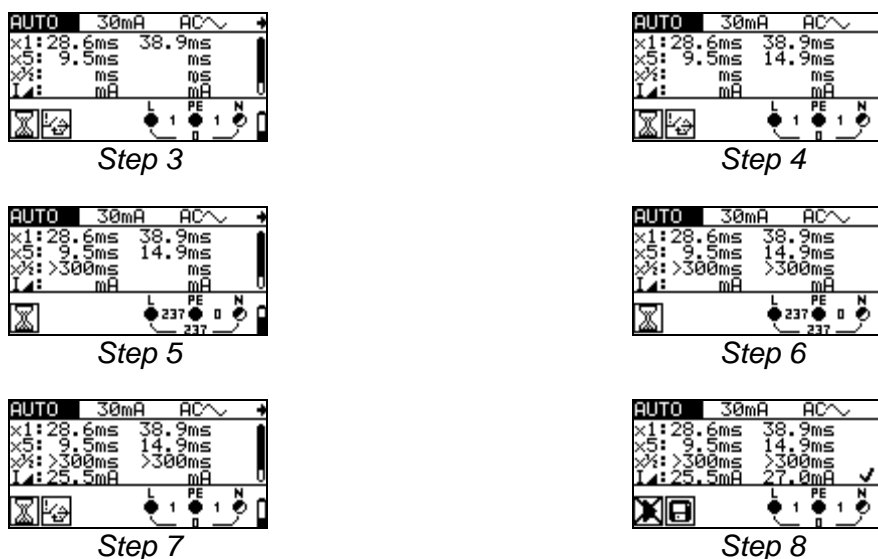
Figure 5.21: Individual steps in RCD auto-test

Top   *Bottom*

Figure 5.22: Two parts of result field in RCD auto-test

Displayed results:

x1 .... step 1 trip-out time ($I_\Delta = I_{\Delta N}$, 0°)
x1 .... step 2 trip-out time ($I_\Delta = I_{\Delta N}$, 180°)
x5 .... step 3 trip-out time ($I_\Delta = 5 \times I_{\Delta N}$, 0°)
x5 .... step 4 trip-out time ($I_\Delta = 5 \times I_{\Delta N}$, 180°)
x½ .... step 5 trip-out time ($I_\Delta = ½ \times I_{\Delta N}$, 0°)
x½ .... step 6 trip-out time ($I_\Delta = ½ \times I_{\Delta N}$, 180°)
I⊿ .... step 7 trip-out current (0°)
I⊿ .... step 8 trip-out current (180°)
Uc .... contact voltage for rated $I_{\Delta N}$

Notes:
- ❑ The auto-test sequence is immediately stopped if any incorrect condition is detected, e.g. excessive Uc or trip-out time out of bounds.
- ❑ Auto test is finished without x5 tests in case of testing the RCD types A and F with rated residual currents of $I_{\square N}$ = 300 mA, 500 mA, and 1000 mA. In this case auto test result passes if all other results pass, and indications for x5 are omitted.
- ❑ Tests for sensitivity (I⊿, steps 7 and 8) are omitted for selective type RCD.

5.5 Fault loop impedance and prospective fault current

Fault loop is a loop comprised by mains source, line wiring and PE path to the mains source. The instrument measures the impedance of the loop and calculates the short circuit current. The measurement is covered by requirements of the EN 61557-3 standard.

See chapter **4.2 Function selection** for instructions on key functionality.
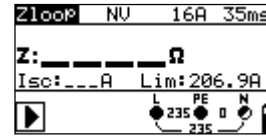
Figure 5.23: Fault loop impedance

Test parameters for fault loop impedance measurement

Test	Selection of **fault loop impedance sub-function** [Zloop, Zs rcd]
Fuse type	Selection of **fuse type** [---, NV, gG, B, C, K, D]
Fuse I	**Rated current** of selected fuse
Fuse T	**Maximum breaking time** of selected fuse
Lim	**Minimum short circuit current** for selected fuse

See Appendix A for reference fuse data.

Circuits for measurement of fault loop impedance
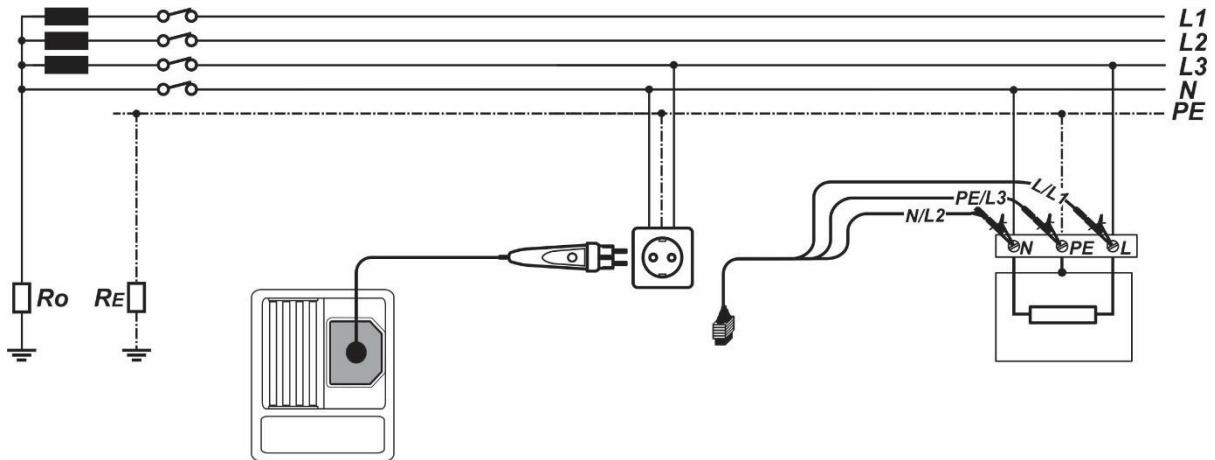
Figure 5.24: Connection of plug commander and 3-wire test lead

Fault loop impedance measurement procedure

❏ Select the `Zloop` function using function selector switch.
❏ Set sub-function to `Zloop` or `Zs rcd` using **UP / DOWN** keys.
❏ Select test **parameters** (optional).
❏ **Connect** test cable to the instrument.
❏ **Connect** test leads to the item to be tested (see *Figure 5.17* and *Figure 5.24*).
❏ Press the **TEST** key to perform the measurement.
❏ **Store** the result by pressing the **MEM** key   .
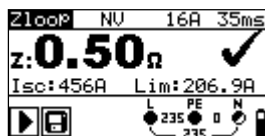
Figure 5.25: Example of loop impedance measurement result

Displayed results:

Z............... fault loop impedance
Isc .... prospective fault current,
Lim........... low limit prospective short-circuit current value

Prospective fault current I_{SC} is calculated from measured impedance as follows:

$$I_{SC} = \frac{Un \times k_{SC}}{Z}$$

where:
Un......... Nominal U_{L-PE} voltage (see table below),
ksc........ Correction factor for Isc (see chapter *4.3.5 Isc factor*).

U_n	Input voltage range (L-PE)
110 V	(93 V $\leq U_{L-PE} \leq$ 134 V)
230 V	(185 V $\leq U_{L-PE} \leq$ 266 V)

Notes:

❏ High fluctuations of mains voltage can influence the measurement results (the noise sign ⎍ is displayed in the message field). In this case it is recommended to repeat few measurements to check if the readings are stable.
❏ This measurement will trip-out the RCD in RCD-protected electrical installation if test Zloop is selected.
❏ Select Zs rcd measurement to prevent trip-out of RCD in RCD protected installation.

5.6 Line impedance and prospective short-circuit current / Voltage drop

Line impedance is measured in loop comprising of mains voltage source and line wiring. Line impedance is covered by the requirements of the EN 61557-3 standard.

The Voltage drop sub-function is intended to check that a voltage in the installation stays above acceptable levels if the highest current is flowing in the circuit. The highest current is defined as the nominal current of the circuit's fuse. The limit values are described in the standard EN 60364-5-52.

Sub-functions:

- ❑ Z LINE - Line impedance measurement according to EN 61557-3 and
- ❑ ΔU – Voltage drop measurement.

See chapter *4.2 Function selection* for instructions on key functionality.
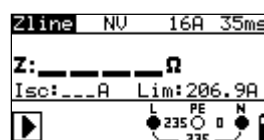
Figure 5.26: Line impedance
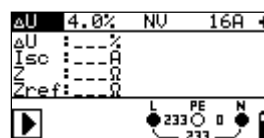
Figure 5.27: Voltage drop

Test parameters for line impedance measurement

Test	Selection of line impedance [Zline] or voltage drop [ΔU] sub-function
FUSE type	Selection of **fuse type** [---, NV, gG, B, C, K, D]
FUSE I	**Rated current** of selected fuse
FUSE T	**Maximum breaking time** of selected fuse
Lim	**Minimum short circuit current** for selected fuse.

See Appendix A for reference fuse data.

Additional test parameters for voltage drop measurement

ΔU$_{MAX}$	**Maximum voltage drop** [3.0 % ÷ 9.0 %].

Additional key:

HELP / CAL	*Click*	Measures Zref value for ΔU function.
	Keep pressed for 1s	Enters Help screen.

5.6.1 Line impedance and prospective short circuit current

Circuits for measurement of line impedance
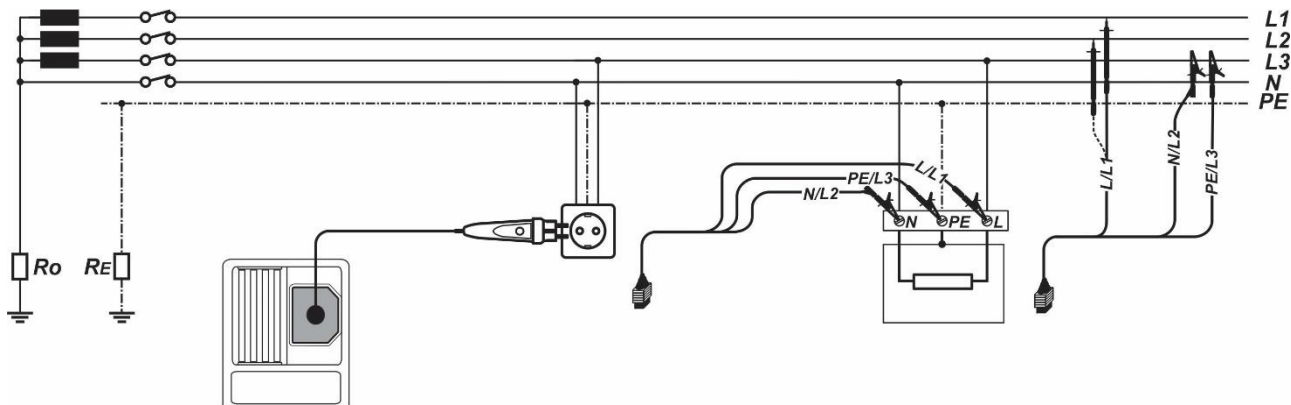
Figure 5.28: Phase-neutral or phase-phase line impedance measurement – connection of plug commander and 3-wire test lead

Line impedance measurement procedure

- ❑ Select the Zline function using the function selector switch.
- ❑ Set sub-function to Zline using **UP / DOWN** keys.
- ❑ Select test **parameters** (optional).
- ❑ **Connect** test cable to the instrument.
- ❑ **Connect** test leads to the item to be tested (see *Figure 5.28*).
- ❑ Press the **TEST** key to perform the measurement.
- ❑ **Store** the result by pressing the **MEM** key.

Figure 5.29: Examples of line impedance measurement result

Displayed results:

    Z.............. line impedance
    Isc .... prospective short-circuit current
    Lim........... low limit prospective short-circuit current value

Prospective short circuit current is calculated as follows:

$$I_{SC} = \frac{Un \times k_{SC}}{Z}$$

where:
Un......... Nominal L-N or L1-L2 voltage (see table below),
ksc........ Correction factor for Isc (see chapter *4.3.5 Isc factor*).

U_n	Input voltage range (L-N or L1-L2)
110 V	($93\ V \leq U_{L-N} < 134\ V$)
230 V	($185\ V \leq U_{L-N} \leq 266\ V$)
400 V	($321\ V < U_{L-L} \leq 485\ V$)

Note:

❑ High fluctuations of mains voltage can influence the measurement results (the noise sign ⊞ is displayed in the message field). In this case it is recommended to repeat few measurements to check if the readings are stable.

5.6.2 Voltage drop

The voltage drop is calculated based on the difference of line impedance at connection points (sockets) and the line impedance at the reference point (usually the impedance at the switchboard).

Circuits for measurement of voltage drop
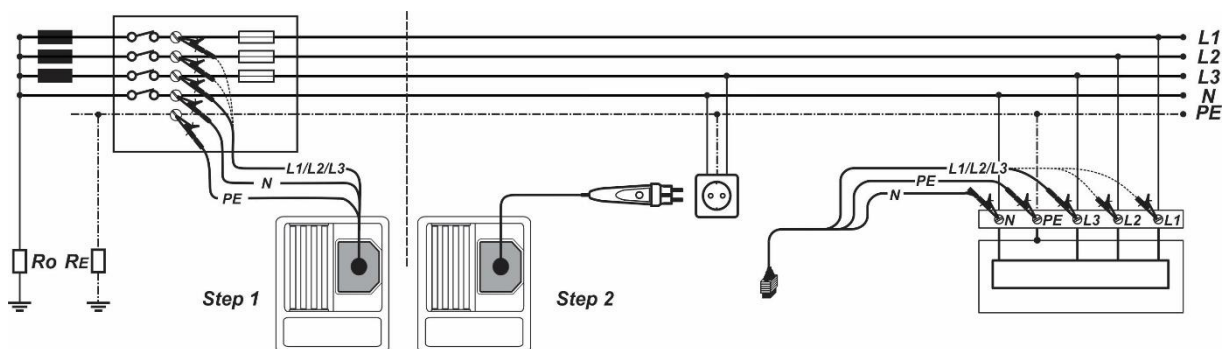
Figure 5.30: Phase-neutral or phase-phase voltage drop measurement – connection of plug commander and 3-wire test lead

Voltage drop measurement procedure

Step 1: Measuring the impedance Zref at origin

❑ Select the Zline function using the function selector switch.
❑ Set sub-function to ΔU using **UP / DOWN** keys.
❑ Select test **parameters** (optional).
❑ **Connect** test cable to the instrument.
❑ **Connect** the test leads to the origin of electrical installation (see *Figure 5.30*).
❑ Press the **CAL** key to perform the measurement.

Step 2: Measuring the voltage drop

❑ Set sub-function to ΔU using **UP / DOWN** keys.
❑ Select test **parameters** (Fuse type must be selected).
❑ **Connect** test cable or plug commander to the instrument.
❑ **Connect** the test leads to the tested points (see *Figure 5.30*).
❑ Press the **TEST** key to perform the measurement.
❑ **Store** the result by pressing the **MEM** key   .
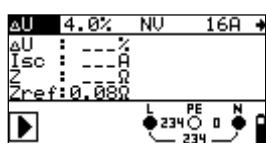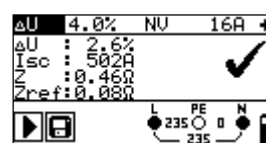
Step 1 - Zref   *Step 2 - Voltage drop*

Figure 5.31: Examples of voltage drop measurement result

Displayed results:

     ΔU .... voltage drop
     Isc .... prospective short-circuit current
     Z .... line impedance at measured point
     Zref .... reference impedance

Voltage drop is calculated as follows:

$$\Delta U[\%] = \frac{(Z - Z_{REF}) \cdot I_N}{U_N} \cdot 100$$

where:
ΔU .... calculated voltage drop
Z .... impedance at test point
Z_{REF} ...... impedance at reference point
I_N .... rated current of selected fuse
U_N .... nominal voltage (see table below)

| U_n	Input voltage range (L-N or L1-L2)
110 V	$(93\ V \leq U_{L-N} < 134\ V)$
230 V	$(185\ V \leq U_{L-N} \leq 266\ V)$
400 V	$(321\ V < U_{L-L} \leq 485\ V)$

Notes:

- ❑ If the reference impedance is not set the value of Z_{REF} is considered as 0.00 Ω.
- ❑ The Z_{REF} is cleared (set to 0.00 Ω) if pressing CAL key while instrument is not connected to a voltage source.
- ❑ I_{SC} is calculated as described in chapter 5.6.1 Line impedance and prospective short circuit current
- ❑ If the measured voltage is outside the ranges described in the table above the ΔU result will not be calculated.
- ❑ High fluctuations of mains voltage can influence the measurement results (the noise sign ⌐⌐ is displayed in the message field). In this case it is recommended to repeat few measurements to check if the readings are stable.

5.7 Earth resistance

Earth resistance is one of the most important parameters for protection against electric shock. Main earthing arrangements, lightning systems, local earthings, soil resistivity etc can be verified with the earthing resistance test. The measurement conforms to the EN 61557-5 standard.

The Earth resistance main function is 3-wire earth resistance test method for standard earth resistance tests with two earthing rods.

See chapter ***4.2 Function selection*** for instructions on key functionality.
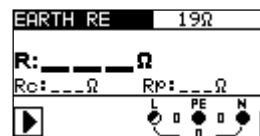
Figure 5.32: Earth resistance

Test parameters for earth resistance measurement

Test	**Test configuration** [EARTH RE]
Limit	**Maximum resistance** [OFF, 1 $\Omega \div$ 5 kΩ]

Earth resistance measurements procedure

- ❑ Select EARTH function using the function selector switch.
- ❑ Enable and set **limit** value (optional).
- ❑ **Connect** test leads to the instrument.
- ❑ **Connect** the item to be tested (see *Figure 5.33 and Figure 5.34)*.
- ❑ Press the **TEST** key to perform the measurement.
- ❑ **Store** the result by pressing the **MEM** key   .

5.7.1 Standard earthing resistance measurement

Connections for earth resistance measurement
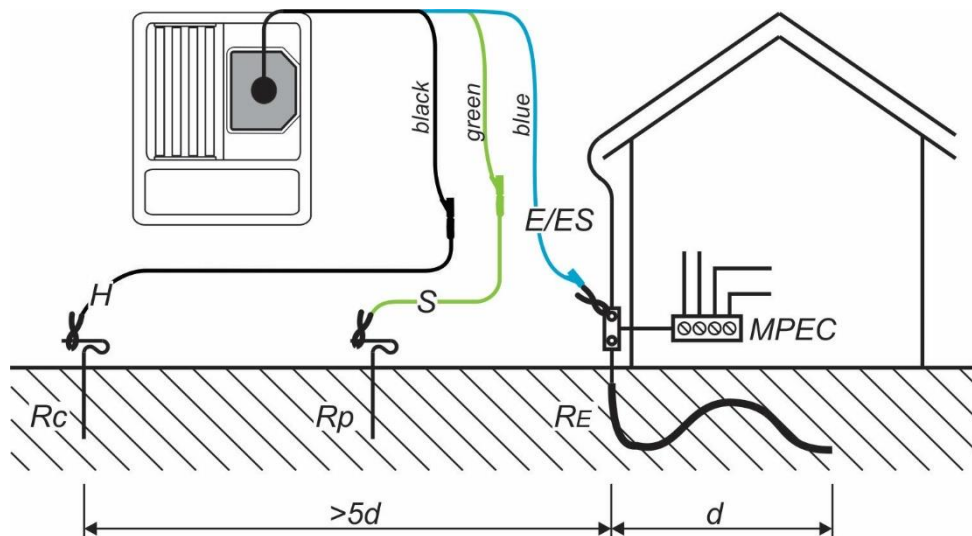
Figure 5.33: Resistance to earth, measurement of main installation earthing
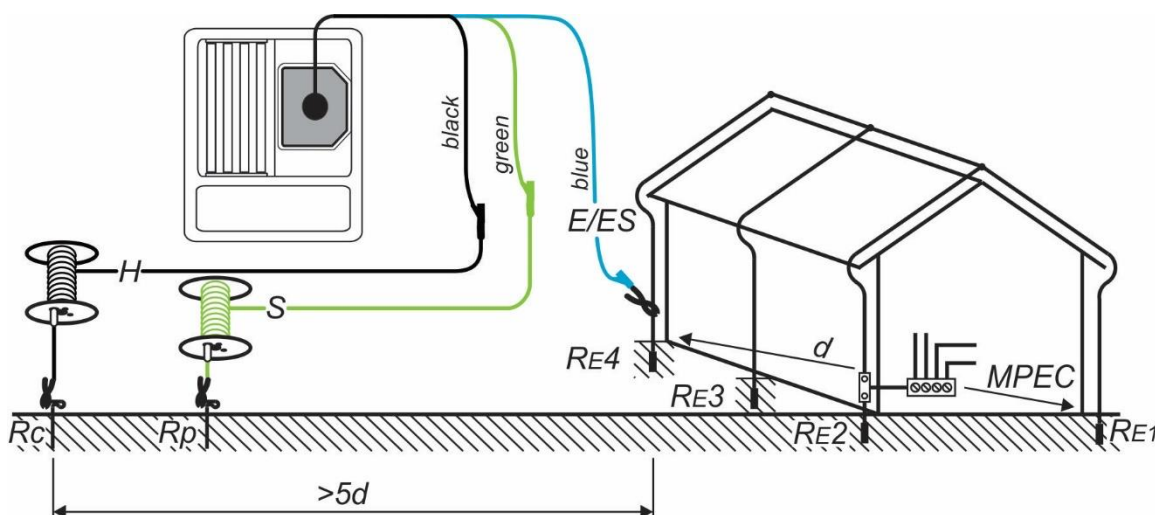
Figure 5.34: Resistance to earth, measurement of a lighting protection system

Figure 5.35: Example of earth resistance measurement result

Displayed results for earth resistance measurement:
     R .... earth resistance
     Rp .... resistance of S (potential) probe
     Rc .... resistance of H (current) probe

Notes:

- High resistance of S and H probes could influence the measurement results. In this case, "Rp" and "Rc" warnings are displayed. There is no PASS / FAIL indication in this case.
- High noise currents and voltages in earth could influence the measurement results. The tester displays the warning in this case.
- Probes must be placed at sufficient distance from the measured object.

5.8 PE test terminal

It can happen that a dangerous voltage is applied to the PE wire or other accessible metal parts. This is a very dangerous situation since the PE wire and MPEs are considered to be earthed. An often reason for this fault is incorrect wiring (see examples below).
When touching the TEST key in all functions that requires mains supply the user automatically performs this test.

Examples for application of PE test terminal
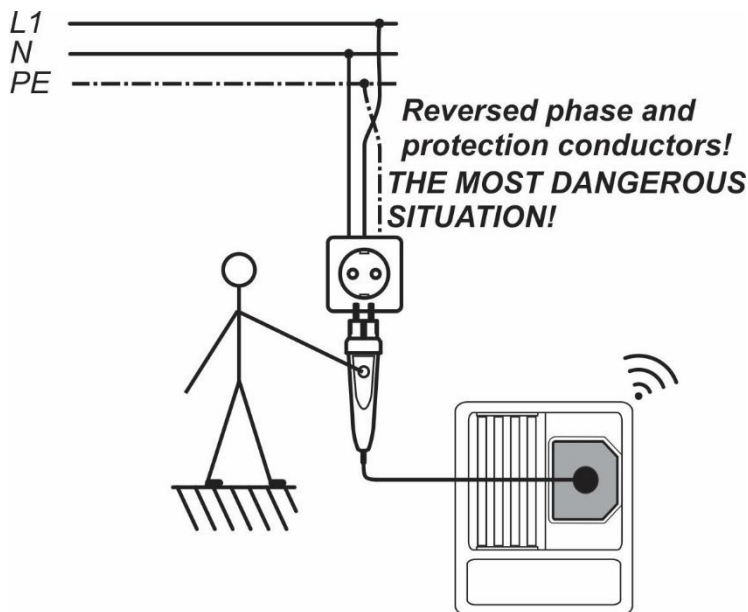
Figure 5.36: Reversed L and PE conductors (plug commander)
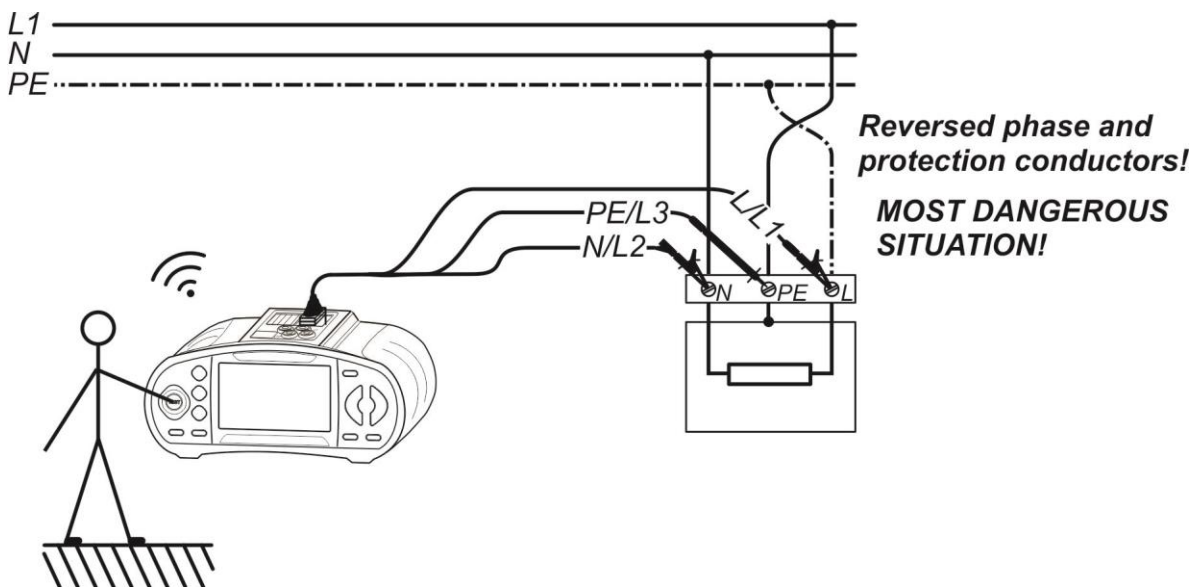
Figure 5.37: Reversed L and PE conductors (application of 3-wire test lead)

PE terminal test procedure

> ❑ **Connect** test cable to the instrument.
> ❑ **Connect** test leads to the item to be tested (see *Figure 5.36* and *Figure 5.37*).
> ❑ **Touch** PE test probe (the **TEST** key) for at least one second.
> ❑ If PE terminal is connected to phase voltage the warning message is displayed, instrument buzzer is activated, and further measurements are disabled in Zloop and RCD functions.

Warning:
> ❑ If dangerous voltage is detected on the tested PE terminal, immediately stop all measurements, find and remove the fault!

Notes:
> ❑ PE test terminal is active in all test and measurements except in the VOLTAGE, Low ohm, Earth and Insulation functions.
> ❑ PE test terminal does not operate in case the operator's body is completely insulated from floor or walls!
> ❑ For operation of PE test terminal on commanders refer to chapter *Appendix D – Commanders*.

5.9 PE conductor resistance

In TN system instrument measures the resistance of the protection conductor from the power transformer to the measurement site.

In TT system the resistance of protection conductor from mains outlet to earth electrode and back to the power transformer via soil and the transformers earthing system is measured.

See chapter **4.2 Function selection** for instructions on key functionality.
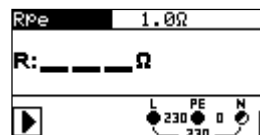
Figure 5.38: PE conductor resistance

Test parameters for PE conductor resistance measurement

Test	Selection of PE conductor resistance sub-function [Rpe,Rpe(rcd)]
Lim	**Maximum resistance** [OFF, 0.1 Ω ÷ 20.0 Ω].

Circuits for measurement of PE conductor resistance
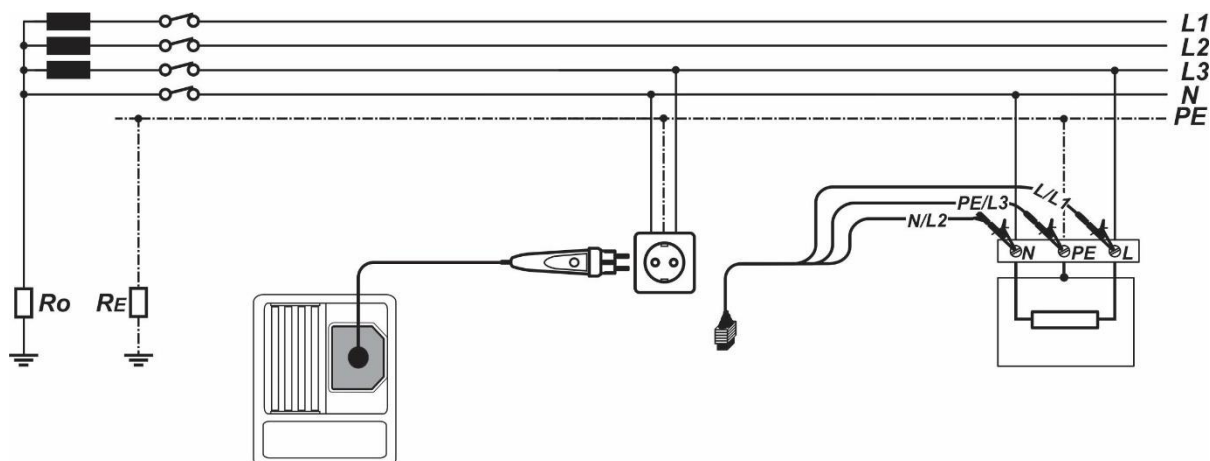
Figure 5.39: Connection of plug commander and 3-wire test lead

PE conductor resistance measurement procedure

- ❑ Select the Rpe function using the function selector switch.
- ❑ Set sub-function to Rpe or Rpe(rcd) using **UP / DOWN** keys.
- ❑ Select test **parameters** (optional).
- ❑ **Connect** test cable to the instrument.
- ❑ **Connect** test leads to the item to be tested (see *Figure 5.39*).
- ❑ Press the **TEST** key to perform the measurement.
- ❑ **Store** the result by pressing the **MEM** key (optional).

Figure 5.40: Examples of PE conductor resistance measurement result

Displayed results:

R .... PE conductor resistance

Notes:

- ❑ High fluctuations of mains voltage can influence the measurement results (the noise sign ⎓ is displayed in the message field). In this case it is recommended to repeat few measurements to check if the readings are stable.
- ❑ This measurement will trip-out the RCD in RCD-protected electrical installation if test Rpe is selected.
- ❑ Select Rpe(rcd) measurement to prevent trip-out of RCD in RCD protected installation.

6 Auto-sequences

Auto-sequences are intended to perform automatic executing of pre-defined measurement sequences. Sequences are divided into three groups, each for selected supply system:

- ❏ AUTO TT,
- ❏ AUTO TN (RCD) and
- ❏ AUTO TN.

The selected sequence is carried out in one set of automatic tests, guided by the instrument.

See chapter *4.2 Function selection* for instructions on key functionality.
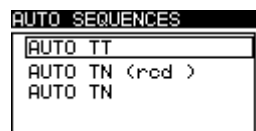
Figure 6.1: Main auto-sequence menu

Keys in main auto-sequence menu

UP / DOWN	Selects auto-sequence.
TEST	Enters selected auto-test sequence.
Function selector switch	Exits back to selected test / measurement function.
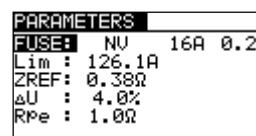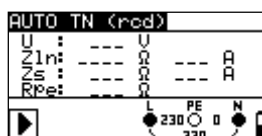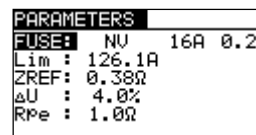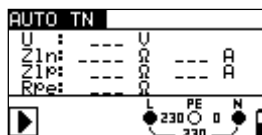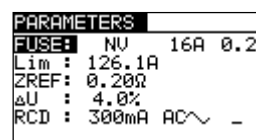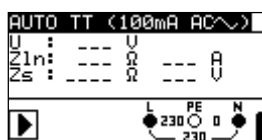
Figure 6.2: Auto-sequence menus

Figure 6.3: Editing parameters menus

Keys in auto-sequence and editing parameters menu

Key	Auto-sequence menu	Editing parameters menu
TAB	Enters viewing/editing test parameters.	Selects the test parameter to be set or modified.
UP / DOWN		Sets or modifies test parameters.
TEST	Runs selected auto-sequence.	Runs selected auto-sequence.
HELP / CAL *Click*	Switch between screens.	Measuring reference line impedance (when ZREF is selected).
HELP / CAL *Keep pressed for 1 s*	Enters help screens.	Enters help screens.
MEM	Stores auto-test results.	
ESC	Exits back to previous menu.	Exits back to previous menu with saving changes.

The following tests / measurements can be performed for selected AutoTest. Parameters in each AutoTest are user-defined as follows.

Auto-sequence	Test / measurement	Available editable parameters	
AUTO TT	VOLTAGE Z LINE ΔU* Zs rcd Uc	FUSE ZREF ΔU RCD	fuse type, rated current, maximal braking time, minimal short-circuit current reference line impedance voltage drop limit value nominal current, RCD type, maximal contact voltage
AUTO TN (RCD)	VOLTAGE Z LINE ΔU* Zs rcd Rpe(rcd)	FUSE ZREF ΔU RPE	fuse type, rated current, maximal braking time, minimal short-circuit current reference line impedance voltage drop limit value maximal PE line resistance
AUTO TN	VOLTAGE Z LINE ΔU* Z LOOP Rpe	FUSE ZREF ΔU RPE	fuse type, rated current, maximal braking time, minimal short-circuit current reference line impedance voltage drop limit value maximal PE line resistance

* applicable only if Z_{REF} is set

Circuit for automatic measurement
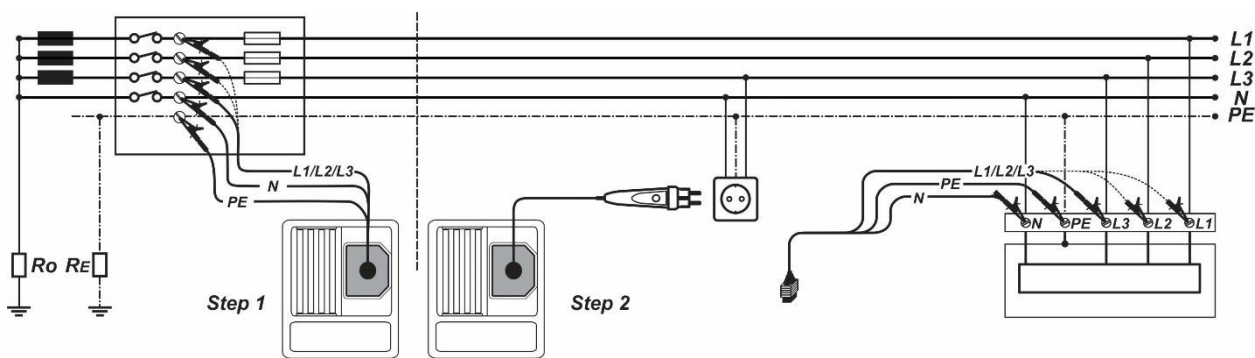
Figure 6.4: Auto-sequence setup

Automatic measurement procedure

- ❑ Select the AUTO SEQUENCES function using the function selector switch.
- ❑ Select auto-sequence AUTO TT, AUTO TN (rcd), or AUTO TN.
- ❑ Select test **parameters**.
- ❑ **Connect** test cable to the instrument.
- ❑ **Connect** the test leads to the origin of electrical installation (see *Figure 6.4 – step 1*)(optional).
- ❑ Press the **CAL** key to perform the Z_{REF} measurement (optional).
- ❑ **Connect** test leads to the item to be tested (see *Figure 6.4 – step 2*).
- ❑ Press the **TEST** key to start the auto-sequence.
- ❑ **Store** the result by pressing the **MEM** key (optional).

Step 1   *Step 2*   *Step 3*

Figure 6.5: Individual steps of AUTO TT auto-sequence
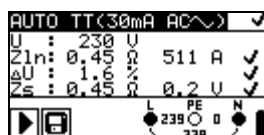
Figure 6.6: Example of AUTO TT auto-sequence results

Displayed results during auto-sequence and saved results

Voltage

Displayed results for single phase system:

Uln .... voltage between phase and neutral conductors
Ulpe .... voltage between phase and protective conductors
Unpe .... voltage between neutral and protective conductors
f .... frequency

Line impedance

Z .... line impedance
Isc .... prospective short-circuit current

Lim........... low limit prospective short-circuit current value

Loop impedance (Zs or Zs$_{RCD}$)

Z............... loop impedance
Isc .... prospective fault current
Lim........... low limit prospective fault current value

PE conductor resistance (Rpe or Rpe$_{RCD}$)

R .... PE conductor resistance

Displayed results once auto-sequence finished and recalled results:
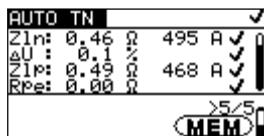
Figure 6.7: Example of recalled AUTO TN auto-sequence results

Function	Results field	
	Left value on display	**Right value on display**
U	**Voltage**	
	Voltage between phase and neutral	
Zln	**Line impedance**	
	Line impedance	Prospective short-circuit current
ΔU*	**Voltage drop**	
	Voltage drop (if available)	
Zs	**Loop impedance**	
	Loop impedance	Contact voltage (AUTO TT only)or Prospective fault current (AUTO TT excepted)
Zlp	**Loop impedance**	
	Loop impedance	Prospective fault current
Rpe	**PE conductor resistance**	
	PE conductor resistance	

Notes:
- ❑ Before starting the auto-sequence, all settings of parameters should be checked.
- ❑ ΔU measurement in each auto-sequence is enabled only if Z$_{REF}$ is set.

7 Data handling

7.1 Memory organization

Measurement results together with all relevant parameters can be stored in the instrument's memory. After the measurement is completed, results can be stored to the flash memory of the instrument, together with the sub-results and function parameters.

7.2 Data structure

The instrument's memory place is divided into 4 levels each containing 199 locations. The number of measurements that can be stored into one location is not limited.

The data structure field describes the location of the measurement (which object, block, fuse and connection) and where can be accessed.
In the measurement field there is information about type and number of measurements that belong to the selected structure element (object and block and fuse and connection).
The main advantages of this system are:

- ❑ Test results can be organized and grouped in a structured manner that reflects the structure of typical electrical installations.
- ❑ Customized names of data structure elements can be uploaded from InstalLink   PRO PCSW.
- ❑ Simple browsing through structure and results.
- ❑ Test reports can be created with no or little modifications after downloading results to a PC.
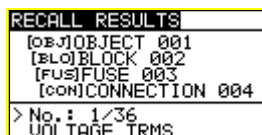
Figure 7.1: Data structure and measurement fields

Data structure field

RECALL RESULTS	Memory operation menu
[OBJ]OBJECT 001 [BLO]BLOCK 002 [FUS]FUSE 003 [CON]CONNECTION 004	Data structure field
[OBJ]OBJECT 001	**1st level:** **OBJECT:** Default location name (object and its successive number). **001:** No. of selected element.
[BLO]BLOCK 002	**2nd level:** **BLOCK:** Default location name (block and its successive number). **002:** No. of selected element.
[FUS]FUSE 003	**3rd level:** **FUSE:** Default location name (fuse and its successive number). **003:** No. of selected element.

[con]CONNECTION 004	**4th level:** **CONNECTION:** Default location name (connection and its successive number). **004:** No. of selected element.
No.: 20 [132]	No. of measurements in selected location [No. of measurements in selected location and its sub-locations]

Measurement field

VOLTAGE TRMS	Type of stored measurement in the selected location.
No.: 1/36	No. of selected test result / No. of all stored test results in selected location.

7.3 Storing test results

After the completion of a test the results and parameters are ready for storing (🖫 icon is displayed in the information field). By pressing the **MEM** key, the user can store the results.

Figure 7.2: Save test menu

FREE:96.3%	Memory available for storing results.

Keys in save test menu - data structure field

TAB	Selects the location element (Object / Block / Fuse / Connection)
UP / DOWN	Selects number of selected location element (1 to 199)
MEM	Saves test results to the selected location and returns to the measuring function.
ESC / TEST	Exits back to measuring function without saving.
Function selector switch	Switches to other test / measuring function or settings menu without saving.

Notes:
- ❑ The instrument offers to store the result to the last selected location by default.
- ❑ If the measurement is to be stored to the same location as the previous one just press the MEM key twice.

7.4 Recalling test results

Press the **MEM key** in every measuring function when there is no result available for storing or select MEMORY in the SETTINGS menu.
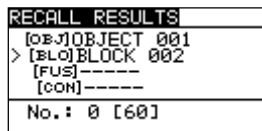
Figure 7.3: Recall menu - installation structure field selected
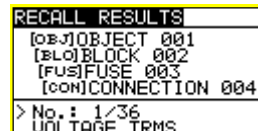
Figure 7.4: Recall menu - measurements field selected

Keys in recall memory menu (installation structure field selected):

TAB	Selects the location element (Object / Block / Fuse / Connection).
UP / DOWN	Selects number of selected location element (1 to 199).
ESC	Exits back to measuring function or memory menu.
Function selector switch	Switches to other test / measuring function or settings.
TEST / MEM	Enters measurements field.

Keys in recall memory menu (measurements field selected):

UP / DOWN	Selects the stored measurement.
TAB / ESC	Returns to installation structure field.
Function selector switch	Switches to other test / measuring function or settings.
TEST / MEM	View selected measurement results.
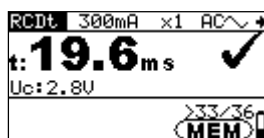
Figure 7.5: Example of recalled measurement result

Keys in recall memory menu (measurement results are displayed)

UP / DOWN	Displays measurement results stored in selected location.
MEM / ESC	Returns to measurements field.
TEST	Returns to installation structure field.
Function selector switch	Switches to other test / measuring function or settings.

7.5 Clearing stored data

7.5.1 Clearing complete memory content

Select **CLEAR ALL MEMORY** in **MEMORY menu**. A warning will be displayed.
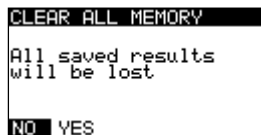
Figure 7.6: Clear all memory

Keys in clear all memory menu

TEST	Confirms clearing of complete memory content (YES must be selected with **UP / DOWN** keys).
ESC	Exits back to memory menu without changes.
Function selector switch	Switches to test / measuring function without changes.
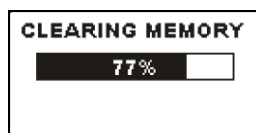
Figure 7.7: Clearing memory in progress

7.5.2 Clearing measurement(s) in selected location

Select **DELETE RESULTS** in **MEMORY menu**.
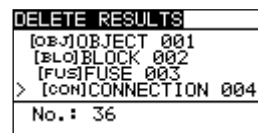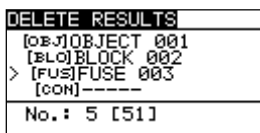
Figure 7.8: Clear measurements menu (data structure field selected)

Keys in delete results menu (installation structure field selected):

TAB	Selects the location element (Object / Block / Fuse / Connection).
UP / DOWN	Selects number of selected location element (1 to 199)
Function selector switch	Switches to test / measuring function.
ESC	Exits back to memory menu.
TEST	Enters dialog box for deleting all measurements in selected location and its sub-locations.

Keys in dialog for confirmation to clear results in selected location:

TEST	Deletes all results in selected location.

MEM / ESC	Exits back to delete results menu without changes.
Function selector switch	Switches to test / measuring function without changes.

7.5.3 Clearing individual measurements

Select **DELETE RESULTS** in **MEMORY menu**.
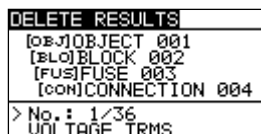
Figure 7.9: Menu for clearing individual measurement (installation structure field selected)

Keys in delete results menu (installation structure field selected):

TAB	Selects the location element (Object / Block / Fuse / Connection).
UP / DOWN	Selects number of selected location element (1 to 199)
Function selector switch	Switches to test / measuring function.
ESC	Exits back to memory menu.
MEM	Enters measurements field for deleting individual measurements.

Keys in delete results menu (measurements field selected):

UP / DOWN	Selects measurement.
TEST	Opens dialog box for confirmation to clear selected measurement.
TAB / ESC	Returns to installation structure field.
Function selector switch	Switches to test / measuring function.

Keys in dialog for confirmation to clear selected result(s):

TEST	Deletes selected measurement result.
MEM / TAB / ESC	Exits back to measurements field without changes.
Function selector switch	Switches to test / measuring function without changes.

Figure 7.10: Dialog for confirmation
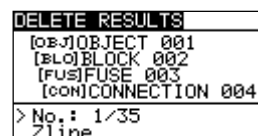
Figure 7.11: Display after measurement was cleared

7.5.4 Renaming installation structure elements (upload from PC)

Default installation structure elements are »Object«, »Block«, »Fuse« and »Connection«.
In the PCSW package InstalLink   -PRO default names can be changed with customized names
that corresponds the installation under test. Refer to PCSW InstalLink   -PRO HELP for
information how to upload customized installation names to the instrument.

```
RECALL RESULTS
 [OBJ]APPARTMENT1
 [BLO]MAIN-BOARD
> [FUS]KITCHEN

 No.: 72
```

Figure 7.12: Example of menu with customized installation structure names

7.5.5 Renaming installation structure elements with serial barcode reader or RFID reader

Default installation structure elements are »Object«, »Block«, »Fuse« and »Connection«.
When the instrument is in the SAVE RESULTS menu location ID can be scanned from a barcode
label with the barcode reader or can be read from a RFID tag with the RFID reader.
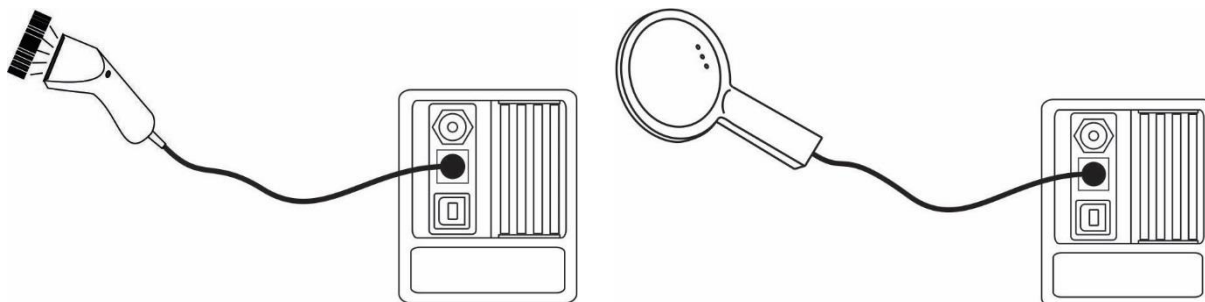
Figure 7.13: Connection of the barcode reader and RFID reader

How to change the name of memory location

❑   Connect the barcode reader or RFID reader to the instrument.
❑   In Save menu select memory location to be renamed.
❑   A new location name (scanned from a barcode label or a RFID tag) will be accepted by
    the instrument. A successful receive of the barcode or RFID tag is confirmed by two
    short confirmation beeps.

Note:
❑   Use only barcode readers and RFID readers delivered by NIEAF-SMITT or authorized
    distributor.

7.6 Communication

Stored results can be transferred to a PC. A special communication program on the PC automatically identifies the instrument and enables data transfer between the instrument and the PC.

There are three communication interfaces available on the instrument: USB, RS 232 and Bluetooth.

7.6.1 USB and RS232 communication

The instrument automatically selects the communication mode according to detected interface. USB interface has priority.

Figure 7.14: Interface connection for data transfer over PC COM port

How to establish an USB or RS-232 link:

> ❑ RS-232 communication: connect a PC COM port to the instrument PS/2 connector using the PS/2 - RS232 serial communication cable;
> ❑ USB communication: connect a PC USB port to the instrument USB connector using the USB interface cable.
> ❑ Switch on the PC and the instrument.
> ❑ Run the InstalLink   PRO program.
> ❑ The PC and the instrument will automatically recognize each other.
> ❑ The instrument is prepared to communicate with the PC.

The program InstalLink   PRO is a PC software running on Windows XP, Windows Vista, Windows 7, and Windows 8. Read the file README_InstalLink   .txt on CD for instructions about installing and running the program.

Note:
> ❑ USB drivers should be installed on PC before using the USB interface. Refer to USB installation instructions available on installation CD.

7.6.2 Bluetooth communication

How to configure a Bluetooth link between instrument and PC

For Bluetooth communication with PC a Standard Serial Port over Bluetooth link for Bluetooth dongle A 1436 must be configured first.

> - Switch Off and On the instrument.
> - Be sure that the Bluetooth dongle A1436 is properly initialized. If not the Bluetooth dongle must be initialized as described in chapter 4.3.7 Communication   .
> - On PC configure a Standard Serial Port to enable communication over Bluetooth link between instrument and PC. Usually no code for pairing the devices is needed.
> - Run the *InstalLink   PRO* program*.*
> - The PC and the instrument will automatically recognize each other.
> - The instrument is prepared to communicate with the PC.

How to configure a Bluetooth link between instrument and Android device

> - Switch Off and On the instrument.
> - Be sure that the Bluetooth dongle A1436 is properly initialized. If not the Bluetooth dongle must be initialized as described in chapter 4.3.7 Communication   .
> - Some Android applications automatically carry out the setup of a Bluetooth connection. It is preferred to use this option if it exists.
>   This option is supported by Nieaf-Smitt's Android applications.
> - If this option is not supported by the selected Android application then configure a Bluetooth link via Android device's Bluetooth configuration tool. Usually no code for pairing the devices is needed.
> - The instrument and Android device are ready to communicate.

Notes:
- Sometimes there will be a demand from the PC or Android device to enter the code. Enter code 'NNNN' to correctly configure the Bluetooth link.
- The name of correctly configured Bluetooth device must consist of the instrument type plus serial number, eg. *InstalTest XE-12240429D*. If the Bluetooth dongle got another name, the configuration must be repeated.

8 Upgrading the instrument

The instrument can be upgraded from a PC via the RS232 communication port. This enables to keep the instrument up to date even if the standards or regulations change. The upgrade can be carried with a help of special upgrading software and the communication cable as shown on *Figure 7.14*. Please contact your dealer for more information.

9 Maintenance

Unauthorized persons are not allowed to open the InstalTest instrument. There are no user replaceable components inside the instrument, except the battery and fuses under rear cover.

9.1 Fuse replacement

There are three fuses under back cover of the InstalTest instrument.

- ❑ **F1**
  M 0.315 A / 250 V, 20×5 mm
  This fuse protects internal circuitry for continuity functions if test probes are connected to the mains supply voltage by mistake during measurement.

- ❑ **F2, F3**
  F 4 A / 500 V, 32×6.3 mm (breaking capacity: 50 kA)
  General input protection fuses of test terminals L/L1 and N/L2.

Position of fuses can be seen in *Figure 3.4 Battery and fuse compartment* in chapter *3.3 Back side*.

Warnings:
- ❑ Disconnect all measuring accessory and switch off the instrument before opening battery / fuse compartment cover, hazardous voltage inside!
- ❑ Replace blown fuse with original type only, otherwise the instrument or accessory may be damaged and/or operator's safety impaired!

9.2 Cleaning

No special maintenance is required for the housing. To clean the surface of the instrument or accessory use a soft cloth slightly moistened with soapy water or alcohol. Then leave the instrument or accessory to dry totally before use.

Warnings:
- ❑ Do not use liquids based on petrol or hydrocarbons!
- ❑ Do not spill cleaning liquid over the instrument!

9.3 Periodic calibration

It is essential that the test instrument is regularly calibrated in order that the technical specification listed in this manual is guaranteed. We recommend an annual calibration. Only an authorized technical person can do the calibration. Please contact your dealer for further information.

9.4 Service

For repairs under warranty, or at any other time, please contact your distributor.

10   Technical specifications

10.1   Insulation resistance

Insulation resistance (nominal voltages 50 V$_{DC}$, 100 V$_{DC}$ and 250 V$_{DC}$)
Measuring range according to EN 61557 is 0.15 MΩ÷ 199.9 MΩ.

Measuring range (MΩ)	Resolution (MΩ)	Accuracy
0.00 ÷ 19.99	0.01	±(5 % of reading + 3 digits)
20.0 ÷ 99.9	0.1	±(10 % of reading)
100.0 ÷ 199.9		±(20 % of reading)

Insulation resistance (nominal voltages 500 V$_{DC}$ and 1000 V$_{DC}$)
Measuring range according to EN 61557 is 0.15 MΩ÷ 999 MΩ.

Measuring range (MΩ)	Resolution (MΩ)	Accuracy
0.00 ÷ 19.99	0.01	±(5 % of reading + 3 digits)
20.0 ÷ 199.9	0.1	±(5 % of reading)
200 ÷ 999	1	±(10 % of reading)

Voltage

Measuring range (V)	Resolution (V)	Accuracy
0 ÷1200	1	±(3 % of reading + 3 digits)

Nominal voltages ....50 V$_{DC}$, 100 V$_{DC}$, 250 V$_{DC}$, 500 V$_{DC}$, 1000 V$_{DC}$
Open circuit voltage................................-0 % / +20 % of nominal voltage
Measuring current....................................min. 1 mA at R$_N$=U$_N$×1 kΩ/V
Short circuit current .... max. 3 mA
The number of possible tests................. > 1200, with a fully charged battery
Auto discharge after test.
Specified accuracy is valid if 3-wire test lead is used while it is valid up to 100 MΩ if tip commander is used.
Specified accuracy is valid up to 100 MΩ if relative humidity > 85 %.
In case the instrument gets moistened, the results could be impaired. In such case, it is recommended to dry the instrument and accessories for at least 24 hours.
The error in operating conditions could be at most the error for reference conditions (specified in the manual for each function) ±5 % of measured value.

10.2 Continuity

10.2.1 Resistance R LOW

Measuring range according to EN 61557 is 0.16 $\Omega \div$ 1999 Ω.

Measuring range R (Ω)	Resolution (Ω)	Accuracy
0.00 ÷ 19.99	0.01	±(3 % of reading + 3 digits)
20.0 ÷ 199.9	0.1	±(5 % of reading)
200 ÷ 1999	1	

Measuring range R+, R- (Ω)	Resolution (Ω)	Accuracy
0.0 ÷ 199.9	0.1	±(5 % of reading + 5 digits)
200 ÷ 1999	1	

Open-circuit voltage................................6.5 VDC ÷ 9 VDC
Measuring current...................................min. 200 mA into load resistance of 2 Ω
Test lead compensation..........................up to 5 Ω
The number of possible tests..................> 2000, with a fully charged battery
Automatic polarity reversal of the test voltage.

10.2.2 Resistance CONTINUITY

Measuring range (Ω)	Resolution (Ω)	Accuracy
0.0 ÷ 19.9	0.1	±(5 % of reading + 3 digits)
20 ÷ 1999	1	

Open-circuit voltage................................6.5 VDC ÷ 9 VDC
Short-circuit current ....max. 8.5 mA
Test lead compensation..........................up to 5 Ω

10.3   RCD testing

10.3.1 General data

Nominal residual current (A,AC) ....10 mA, 30 mA, 100 mA, 300 mA, 500 mA,
1000 mA
Nominal residual current accuracy..........-0 / +0.1·IΔ; IΔ = IΔN, 2×IΔN, 5×IΔN
-0.1·IΔ / +0; IΔ = 0.5×IΔN
AS/NZS selected: ± 5 %
Test current shape.................................Sine-wave (AC), pulsed (A, F)
DC offset for pulsed test current ....6 mA (typical)
RCD type...non-delayed, S (time-delayed), PRCD, PRCD-K,
PRCD-S
Test current starting polarity .... 0º or 180º
Voltage range ....93 V ÷ 134 V (45 Hz ÷ 65 Hz)
185 V ÷ 266 V (45 Hz ÷ 65 Hz)

I$_{\Delta N}$ (mA)	I$_{\Delta N}$ × 1/2		I$_{\Delta N}$ × 1		I$_{\Delta N}$ × 2		I$_{\Delta N}$ × 5		RCD I$_\Delta$	
	AC	A, F	AC	A, F	AC	A, F	AC	A, F	AC	A, F
10	5	3.5	10	20	20	40	50	100	✓	✓
30	15	10.5	30	42	60	84	150	212	✓	✓
100	50	35	100	141	200	282	500	707	✓	✓
300	150	105	300	424	600	848	1500	n.a.	✓	✓
500	250	175	500	707	1000	1410	2500	n.a.	✓	✓
1000	500	350	1000	1410	2000	n.a.	n.a.	n.a.	✓	✓

n.a. ....not applicable
AC type..sine wave test current
A, F types…… ....pulsed current

10.3.2 Contact voltage RCD Uc

Measuring range according to EN 61557 is 20.0 V ÷ 31.0V for limit contact voltage 25V
Measuring range according to EN 61557 is 20.0 V ÷ 62.0V for limit contact voltage 50V

Measuring range (V)	Resolution (V)	Accuracy
0.0 ÷ 19.9	0.1	(-0 % / +15 %) of reading ± 10 digits
20.0 ÷ 99.9	0.1	(-0 % / +15 %) of reading

The accuracy is valid if mains voltage is stabile during the measurement and PE terminal is free of interfering voltages.

Test current .... max. 0.5×I$_{\Delta N}$
Limit contact voltage.............................. 25 V, 50 V
Specified accuracy is valid for complete operating range.

10.3.3 Trip-out time

Complete measurement range corresponds to EN 61557 requirements.
Maximum measuring times set according to selected reference for RCD testing.

Measuring range (ms)	Resolution (ms)	Accuracy
0.0 ÷ 40.0	0.1	±1 ms
0.0 ÷ max. time *	0.1	±3 ms

* For max. time see normative references in chapter *4.3.4 RCD testing*. This specification applies to max. time > 40 ms.

Test current .... ½×$I_{\Delta N}$, $I_{\Delta N}$, 2×$I_{\Delta N}$, 5×$I_{\Delta N}$
5×$I_{\Delta N}$ is not available for $I_{\Delta N}$=1000 mA (RCD type AC) or $I_{\Delta N} \geq$ 300 mA (RCD types A, F).
2×$I_{\Delta N}$ is not available for $I_{\Delta N}$=1000 mA (RCD types A, F) Specified accuracy is valid for complete operating range.

10.3.4 Trip-out current

Trip-out current
Complete measurement range corresponds to EN 61557 requirements.

Measuring range I_Δ	Resolution I_Δ	Accuracy
0.2×$I_{\Delta N}$÷ 1.1×$I_{\Delta N}$ (AC type)	0.05×$I_{\Delta N}$	±0.1×$I_{\Delta N}$
0.2×$I_{\Delta N}$÷ 1.5×$I_{\Delta N}$ (A type, $I_{\Delta N}$≥30 mA)	0.05×$I_{\Delta N}$	±0.1×$I_{\Delta N}$
0.2×$I_{\Delta N}$÷ 2.2×$I_{\Delta N}$ (A type, $I_{\Delta N}$<30 mA)	0.05×$I_{\Delta N}$	±0.1×$I_{\Delta N}$
0.2×$I_{\Delta N}$÷ 2.2×$I_{\Delta N}$ (B type)	0.05×$I_{\Delta N}$	±0.1×$I_{\Delta N}$

Trip-out time

Measuring range (ms)	Resolution (ms)	Accuracy
0 ÷ 300	1	±3 ms

Contact voltage

Measuring range (V)	Resolution (V)	Accuracy
0.0 ÷ 19.9	0.1	(-0 % / +15 %) of reading ± 10 digits
20.0 ÷ 99.9	0.1	(-0 % / +15 %) of reading

The accuracy is valid if mains voltage is stabile during the measurement and PE terminal is free of interfering voltages.
Specified accuracy is valid for complete operating range.

10.4   Fault loop impedance and prospective fault current

10.4.1 No disconnecting device or FUSE selected

Fault loop impedance
Measuring range according to EN 61557 is 0.25 Ω÷ 9.99kΩ.

Measuring range (Ω)	Resolution (Ω)	Accuracy
0.00 ÷ 9.99	0.01	±(5 % of reading + 5 digits)
10.0 ÷ 99.9	0.1	
100 ÷ 999	1	± 10 % of reading
1.00 k ÷ 9.99 k	10	

Prospective fault current (calculated value)

Measuring range (A)	Resolution (A)	Accuracy
0.00 ÷ 9.99	0.01	
10.0 ÷ 99.9	0.1	
100 ÷ 999	1	Consider accuracy of fault loop resistance measurement
1.00 k ÷ 9.99 k	10	
10.0 k ÷ 23.0 k	100	

The accuracy is valid if mains voltage is stabile during the measurement.

Test current (at 230 V)........................... 6.5 A (10 ms)
Nominal voltage range........................... 93 V ÷ 134 V (45 Hz ÷ 65 Hz)
                                                                185 V ÷ 266 V (45 Hz ÷ 65 Hz)

10.4.2 RCD selected

Fault loop impedance
Measuring range according to EN 61557 is 0.46 Ω÷ 9.99 kΩ.

Measuring range (Ω)	Resolution (Ω)	Accuracy
0.00 ÷ 9.99	0.01	±(5 % of reading + 10 digits)
10.0 ÷ 99.9	0.1	
100 ÷ 999	1	± 10 % of reading
1.00 k ÷ 9.99 k	10	

Accuracy may be impaired in case of heavy noise on mains voltage.

Prospective fault current (calculated value)

Measuring range (A)	Resolution (A)	Accuracy
0.00 ÷ 9.99	0.01	
10.0 ÷ 99.9	0.1	
100 ÷ 999	1	Consider accuracy of fault loop resistance measurement
1.00 k ÷ 9.99 k	10	
10.0 k ÷ 23.0 k	100	

Nominal voltage range........................... 93 V ÷ 134 V (45 Hz ÷ 65 Hz)
                                                                185 V ÷ 266 V (45 Hz ÷ 65 Hz)

No trip out of RCD.

10.5 Line impedance and prospective short-circuit current / Voltage drop

Line impedance

Measuring range according to EN 61557 is 0.25 $\Omega \div$ 9.99kΩ.

Measuring range (Ω)	Resolution (Ω)	Accuracy
0.00 ÷ 9.99	0.01	$\pm$(5 % of reading + 5 digits)
10.0 ÷ 99.9	0.1	
100 ÷ 999	1	$\pm$ 10 % of reading
1.00 k ÷ 9.99 k	10	

Prospective short-circuit current (calculated value)

Measuring range (A)	Resolution (A)	Accuracy
0.00 ÷ 0.99	0.01	Consider accuracy of line resistance measurement
1.0 ÷ 99.9	0.1	
100 ÷ 999	1	
1.00 k ÷ 99.99 k	10	
100 k ÷ 199 k	1000	

Test current (at 230 V)........................... 6.5 A (10 ms)
Nominal voltage range........................... 93 V ÷ 134 V (45 Hz ÷ 65 Hz)
                                              185 V ÷ 266 V (45 Hz ÷ 65 Hz)
                                              321 V ÷ 485 V (45 Hz ÷ 65 Hz)

Voltage drop (calculated value)

Measuring range (%)	Resolution (%)	Accuracy
0.0 ÷ 99.9	0.1	Consider accuracy of line impedance measurement(s)*

Z_{REF} measuring range .... 0.00 Ω ÷ 20.0 Ω

*See chapter *5.6.2 Voltage drop* for more information about calculation of voltage drop result.

10.6   PE conductor resistance

10.6.1 No RCD selected

PE conductor resistance

Measuring range (Ω)	Resolution (Ω)	Accuracy
0.00 ÷19.99	0.01	±(5 % of reading + 5 digits)
20.0 ÷ 99.9	0.1	
100.0÷199.9	0,1	± 10 % of reading
200 ÷1999	1	

10.6.2 RCD selected

PE conductor resistance

Measuring range (Ω)	Resolution (Ω)	Accuracy
0.00 ÷ 19.99	0.01	±(5 % of reading + 10 digits)
20.0 ÷ 99.9	0.1	
100.0 ÷ 199.9	0,1	± 10 % of reading
200 ÷ 1999	1	

Accuracy may be impaired in case of heavy noise on mains voltage.

Nominal voltage range........................... 93 V ÷ 134 V (45 Hz ÷ 65 Hz)
                                                                   185 V ÷ 266 V (45 Hz ÷ 65 Hz)

No trip out of RCD.

10.7   Resistance to earth

10.7.1 Standard earthing resistance measurement – 3-wire measurement

Measuring range according to EN61557-5 is 2.00 $\Omega \div$ 1999 Ω.

Measuring range (Ω)	Resolution (Ω)	Accuracy
0.00 $\div$ 19.99	0.01	
20.0 $\div$ 199.9	0.1	$\pm$(5% of reading + 5 digits)
200 $\div$ 9999	1	

Max. auxiliary earth electrode resistance R_C...........100$\times R_E$ or 50 kΩ (whichever is lower)
Max. probe resistance R_P ....100$\times R_E$ or 50 kΩ (whichever is lower)

Additional probe resistance error at R_{Cmax} or $R_{Pmax.}$.$\pm$(10 % of reading + 10 digits)

Additional error at 3 V voltage noise (50 Hz)...........$\pm$(5 % of reading + 10 digits)
Open circuit voltage..<30 VAC
Short circuit current ....< 30 mA
Test voltage frequency ....125 Hz
Test voltage shape ....sine wave
Noise voltage indication threshold ....1 V (< 50 Ω, worst case)

Automatic measurement of auxiliary electrode resistance and probe resistance.
Automatic measurement of voltage noise.

10.8   Voltage, frequency, and phase rotation

10.8.1 Phase rotation

Nominal system voltage range............... 100 V_{AC}÷ 550 V_{AC}
Nominal frequency range....................... 14 Hz ÷ 500 Hz
Result displayed .... 1.2.3 or 3.2.1

10.8.2 Voltage

Measuring range (V)	Resolution (V)	Accuracy
0 ÷ 550	1	±(2 % of reading + 2 digits)

Result type .... True r.m.s. (TRMS)
Nominal frequency range....................... 0 Hz, 14 Hz ÷ 500 Hz

10.8.3 Frequency

Measuring range (Hz)	Resolution (Hz)	Accuracy
0.00 ÷ 9.99	0.01	±(0.2 % of reading + 1 digit)
10.0 ÷ 499.9	0.1	

Nominal voltage range........................... 10 V ÷ 550 V

10.8.4 Online terminal voltage monitor

Measuring range (V)	Resolution (V)	Accuracy
10 ÷ 550	1	±(2 % of reading + 2 digits)

10.9   General data

Power supply voltage............................ 9 V_{DC} (6×1.5 V battery or accu, size AA)
Operation... typical 20 h
Charger socket input voltage .... 12 V ± 10 %
Charger socket input current.................. 400 mA max.
Battery charging current .... 250 mA (internally regulated)
Measuring category .... 600 V CAT III
                                                             300 V CAT IV
Protection classification .... double insulation
Pollution degree.................................... 2
Protection degree .... IP 40

Display .... 128x64 dots matrix display with backlight

Dimensions (w × h × d) .... 23 cm × 10.3 cm × 11.5 cm
Weight .... 1.3 kg, without battery cells

Reference conditions
Reference temperature range................ 10 °C ÷ 30 °C
Reference humidity range...................... 40 %RH ÷ 70 %RH

Operation conditions
Working temperature range .... 0°C ÷ 40 °C
Maximum relative humidity .... 95 %RH (0°C ÷ 40 °C), non-condensing

Storage conditions
Temperature range................................ -10°C ÷ +70 °C
Maximum relative humidity .... 90 %RH (-10°C ÷ +40 °C)
                                                             80 %RH (40°C ÷ 60 °C)

Communication transfer speed
RS 232 .... 57600 baud
USB.. 256000 baud

Size of memory   .... up to 1800 measurements

The error in operating conditions could be at most the error for reference conditions (specified in
the manual for each function) +1 % of measured value + 1 digit, unless otherwise specified in the
manual for particular function.

Appendix A – Fuse table

A.1 Fuse table – IPSC

Fuse type NV

Rated current (A)	Disconnection time [s]				
	35m	**0.1**	**0.2**	**0.4**	**5**
	Min. prospective short- circuit current (A)				
2	32.5	22.3	18.7	15.9	9.1
4	65.6	46.4	38.8	31.9	18.7
6	102.8	70	56.5	46.4	26.7
10	165.8	115.3	96.5	80.7	46.4
16	206.9	150.8	126.1	107.4	66.3
20	276.8	204.2	170.8	145.5	86.7
25	361.3	257.5	215.4	180.2	109.3
35	618.1	453.2	374	308.7	169.5
50	919.2	640	545	464.2	266.9
63	1217.2	821.7	663.3	545	319.1
80	1567.2	1133.1	964.9	836.5	447.9
100	2075.3	1429	1195.4	1018	585.4
125	2826.3	2006	1708.3	1454.8	765.1
160	3538.2	2485.1	2042.1	1678.1	947.9
200	4555.5	3488.5	2970.8	2529.9	1354.5
250	6032.4	4399.6	3615.3	2918.2	1590.6
315	7766.8	6066.6	4985.1	4096.4	2272.9
400	10577.7	7929.1	6632.9	5450.5	2766.1
500	13619	10933.5	8825.4	7515.7	3952.7
630	19619.3	14037.4	11534.9	9310.9	4985.1
710	19712.3	17766.9	14341.3	11996.9	6423.2
800	25260.3	20059.8	16192.1	13545.1	7252.1
1000	34402.1	23555.5	19356.3	16192.1	9146.2
1250	45555.1	36152.6	29182.1	24411.6	13070.1

Fuse type gG

Rated current (A)	Disconnection time [s]				
	35m	**0.1**	**0.2**	**0.4**	**5**
	Min. prospective short- circuit current (A)				
2	32.5	22.3	18.7	15.9	9.1
4	65.6	46.4	38.8	31.9	18.7
6	102.8	70	56.5	46.4	26.7
10	165.8	115.3	96.5	80.7	46.4
13	193.1	144.8	117.9	100	56.2
16	206.9	150.8	126.1	107.4	66.3
20	276.8	204.2	170.8	145.5	86.7
25	361.3	257.5	215.4	180.2	109.3
32	539.1	361.5	307.9	271.7	159.1
35	618.1	453.2	374	308.7	169.5
40	694.2	464.2	381.4	319.1	190.1
50	919.2	640	545	464.2	266.9
63	1217.2	821.7	663.3	545	319.1
80	1567.2	1133.1	964.9	836.5	447.9
100	2075.3	1429	1195.4	1018	585.4

Fuse type B

Rated current (A)	Disconnection time [s]				
	35m	**0.1**	**0.2**	**0.4**	**5**
	Min. prospective short- circuit current (A)				
6	30	30	30	30	30
10	50	50	50	50	50
13	65	65	65	65	65
15	75	75	75	75	75
16	80	80	80	80	80
20	100	100	100	100	100
25	125	125	125	125	125
32	160	160	160	160	160
40	200	200	200	200	200
50	250	250	250	250	250
63	315	315	315	315	315

Fuse type C

Rated current (A)	Disconnection time [s]				
	35m	**0.1**	**0.2**	**0.4**	**5**
	Min. prospective short- circuit current (A)				
0.5	5	5	5	5	2.7
1	10	10	10	10	5.4
1.6	16	16	16	16	8.6
2	20	20	20	20	10.8
4	40	40	40	40	21.6
6	60	60	60	60	32.4
10	100	100	100	100	54
13	130	130	130	130	70.2
15	150	150	150	150	83
16	160	160	160	160	86.4
20	200	200	200	200	108
25	250	250	250	250	135
32	320	320	320	320	172.8
40	400	400	400	400	216
50	500	500	500	500	270
63	630	630	630	630	340.2

Fuse type K

Rated current (A)	Disconnection time [s]				
	35m	**0.1**	**0.2**	**0.4**	
	Min. prospective short- circuit current (A)				
0.5	7.5	7.5	7.5	7.5	
1	15	15	15	15	
1.6	24	24	24	24	
2	30	30	30	30	
4	60	60	60	60	
6	90	90	90	90	
10	150	150	150	150	
13	195	195	195	195	
15	225	225	225	225	
16	240	240	240	240	
20	300	300	300	300	
25	375	375	375	375	
32	480	480	480	480	

Fuse type D

Rated current (A)	Disconnection time [s]				
	35m	**0.1**	**0.2**	**0.4**	**5**
	Min. prospective short- circuit current (A)				
0.5	10	10	10	10	2.7
1	20	20	20	20	5.4
1.6	32	32	32	32	8.6
2	40	40	40	40	10.8
4	80	80	80	80	21.6
6	120	120	120	120	32.4
10	200	200	200	200	54
13	260	260	260	260	70.2
15	300	300	300	300	81
16	320	320	320	320	86.4
20	400	400	400	400	108
25	500	500	500	500	135
32	640	640	640	640	172.8

Appendix B – Accessories for specific measurements

The table below presents recommended standard and optional accessories required for specific measurement. Please see attached list of standard accessories for your set or contact your distributor for further information.

Function	Suitable accessories (Optional with ordering code A….)
Insulation resistance	❑ Test lead, 3 x 1.5 m ❑ Tip commander (A 1401)
R LOWΩ resistance Continuity	❑ Test lead, 3 x 1.5 m ❑ Tip commander (A 1401) ❑ Test lead, 4 m (A 1012)
Line impedance Voltage drop Fault loop impedance PE resistance	❑ Test lead, 3 x 1.5 m ❑ Plug commander (A 1314) ❑ Mains measuring cable ❑ Tip commander (A 1401) ❑ Three-phase adapter with switch (A 1111)
Earth connection resistance	❑ Test lead, 3 x 1.5 m ❑ Plug commander (A 1314) ❑ Mains measuring cable ❑ Tip commander (A 1401)
RCD testing	❑ Test lead, 3 x 1.5 m ❑ Plug commander (A 1314) ❑ Mains measuring cable ❑ Three-phase adapter with switch (A 1111)
Earth resistance - RE	❑ Test lead, 3 x 1.5 m ❑ Earth test set, 3-wire, 20 m (S 2026) ❑ Earth test set, 3-wire, 50 m (S 2027)
Phase sequence	❑ Test lead, 3 x 1.5 m ❑ Three-phase adapter (A 1110) ❑ Three-phase adapter with switch (A 1111)
Voltage, frequency	❑ Test lead, 3 x 1.5 m ❑ Plug commander (A 1314) ❑ Mains measuring cable ❑ Tip commander (A 1401)
Auto sequences	❑ Test lead, 3 x 1.5 m ❑ Plug commander (A 1314) ❑ Mains measuring cable ❑ Tip commander (A 1401)

Appendix C – Country notes

This appendix C contains collection of minor modifications related to particular country requirements. Some of the modifications mean modified listed function characteristics related to main chapters and others are additional functions. Some minor modifications are related also to different requirements of the same market that are covered by various suppliers.

C.1 List of country modifications

The following table contains current list of applied modifications.

Country	Related chapters	Modification type	Note
AT	5.4, C.2.1	Appended	Special G type RCD

C.2 Modification issues

C.2.1 AT modification - G type RCD

Modified is the following related to the mentioned in the chapter 5.4:
- Added G type RCD,
- Time limits are the same as for general type RCD,
- Contact voltage is calculated the same as for general type RCD.

Modifications of the chapter 5.4:

Test parameters for RCD test and measurement

TEST	**RCD sub-function test** [Uc, RCDt, RCD I, AUTO]
I$_{\Box N}$	**Rated RCD residual current sensitivity I$_{\Delta N}$** [10 mA, 30 mA, 100 mA, 300 mA, 500 mA, 1000 mA].
type	**RCD type** [AC, A, F]. **starting polarity** [∿, ∿, ⌢−, ⌄−]. **Characteristic and PRCD selection** [selective Ⓢ, general non-delayed ▢, delayed Ⓖ, PRCD, PRCD-K, PRCD-S].
MUL	**Multiplication factor for test current** [½, 1, 2, 5×I$_{\Box N}$].
Ulim	**Conventional touch voltage limit** [25 V, 50 V].

* Model MI 3102 BT only

Notes:
- Ulim can be selected in the Uc sub-function only.
- Selective (time delayed) RCDs and RCDs with (G) - time delayed characteristic demonstrate delayed response characteristics. They contain residual current integrating mechanism for generation of delayed trip out. However, contact voltage pre-test in the measuring procedure also influences the RCD and it takes a period to recover into idle state. Time delay of 30 s is inserted before performing trip-out test to recover Ⓢ type RCD after pre-tests and time delay of 5 s is inserted for the same purpose for Ⓖ type RCD.

Modification of the chapter 5.4.1

RCD type		Contact voltage Uc proportional to	Rated $I_{\Delta N}$
AC	$\square$, $\boxed{G}$	$1.05 \times I_{\Delta N}$	any
AC	$\boxed{S}$	$2 \times 1.05 \times I_{\Delta N}$	
A, F	$\square$, $\boxed{G}$	$1.4 \times 1.05 \times I_{\Delta N}$	≥ 30 mA
A, F	$\boxed{S}$	$2 \times 1.4 \times 1.05 \times I_{\Delta N}$	
A, F	$\square$, $\boxed{G}$	$2 \times 1.05 \times I_{\Delta N}$	< 30 mA
A, F	$\boxed{S}$	$2 \times 2 \times 1.05 \times I_{\Delta N}$	

Table C.1: Relationship between Uc and $I_{\Delta N}$

Technical specifications remain the same.

Appendix D – Commanders (A 1314, A 1401)

D.1 ⚠ Warnings related to safety

Measuring category of commanders

Plug commander A 1314 ......300 V CAT II

Tip commander A1401
(cap off, 18 mm tip) ....1000 V CAT II / 600 V CAT II / 300 V CAT II
(cap on, 4 mm tip) ....1000 V CAT II / 600 V CAT III / 300 V CAT IV

- ❑ Measuring category of commanders can be lower than protection category of the instrument.
- ❑ If dangerous voltage is detected on the tested PE terminal, immediately stop all measurements, find and remove the fault!
- ❑ When replacing battery cells or before opening the battery compartment cover, disconnect the measuring accessory from the instrument and installation.
- ❑ Service, repairs or adjustment of instruments and accessories is only allowed to be carried out by a competent authorized personnel!

D.2 Battery

The commander uses two AAA size alkaline or rechargeable Ni-MH battery cells.
Nominal operating time is at least 40 h and is declared for cells with nominal capacity of 850 mAh.

Notes:
- ❑ If the commander is not used for a long period of time, remove all batteries from the battery compartment.
- ❑ Alkaline or rechargeable Ni-MH batteries (size AA) can be used. Nieaf-Smitt recommends only using rechargeable batteries with a capacity of 800 mAh or above.
- ❑ Ensure that the battery cells are inserted correctly otherwise the commander will not operate and the batteries could be discharged.
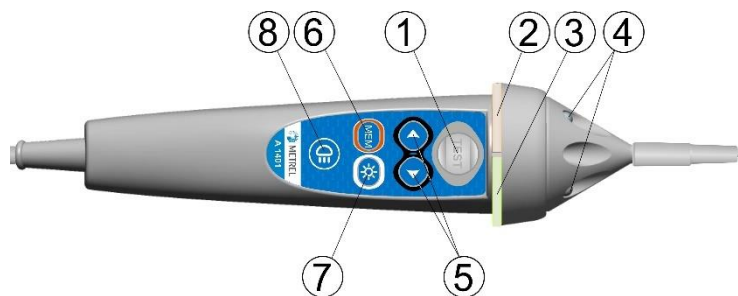
D.3 Description of commanders

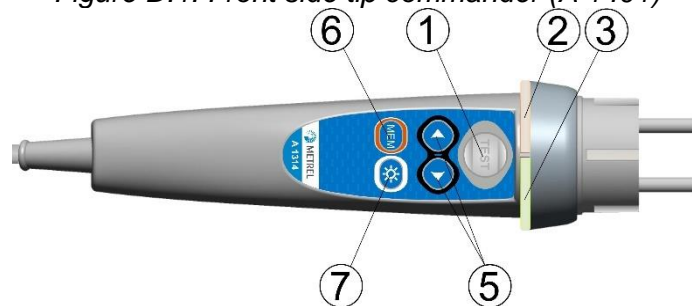*Figure D.1: Front side tip commander (A 1401)*
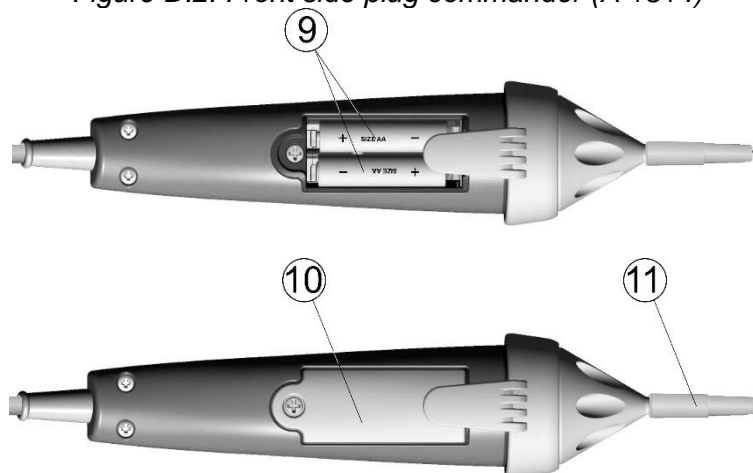

Figure D.2: Front side plug commander (A 1314)

Figure D.3: Back side

Legend:

1	TEST	TEST	Starts measurements.
			Acts also as the PE touching electrode.
2	LED		Left status RGB LED
3	LED		Right status RGB LED
4	LEDs		Lamp LEDs (Tip commander)
5	Function selector		Selects test function.
6	MEM		Store / recall / clear tests in memory of instrument.
7	BL		Switches On / Off backlight on instrument
8	Lamp key		Switches On / Off lamp (Tip commander)
9	Battery cells		Size AAA, alkaline / rechargeable NiMH
10	Battery cover		Battery compartment cover
11	Cap		Removable CAT IV cap (Tip commander)

D.4 Operation of commanders

Both LED yellow	Warning! Dangerous voltage on the commander's PE terminal!
Right LED red	Fail indication
Right LED green	Pass indication
Left LED blinks blue	Commander is monitoring the input voltage
Left LED orange	Voltage between any test terminals is higher than 50 V
Both LEDs blink red	Low battery
Both LEDs red and switch off	Battery voltage too low for operation of commander

PE terminal test procedure

> ❑ **Connect** commander to the instrument.
> ❑ **Connect** commander to the item to be tested (see figure D.4).
> ❑ Touch PE test probe (the **TEST** key) on commander for at least one second.
> ❑ If PE terminal is connected to phase voltage both LEDs will light yellow, the warning message on the instrument is displayed, instrument's buzzer is activated, and further measurements are disabled in Zloop and RCD functions.
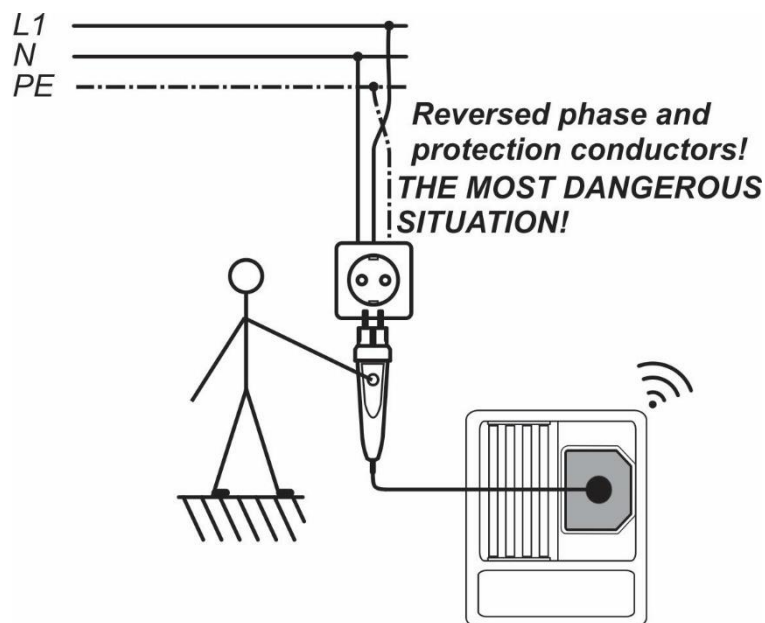

Figure D.4: Reversed L and PE conductors (application of plug commander)